Misura dei Parametri d’ingresso delle Antenne

Richiami sui Parametri S
L’analizzatore di Rete
13

S-Parameters

13.1 Scattering Parameters

Linear two-port (and multi-port) networks are characterized by a number of equivalent circuit parameters, such as their transfer matrix, impedance matrix, admittance matrix, and scattering matrix. Fig. 13.1.1 shows a typical two-port network.

![Two-port network diagram](image)

The transfer matrix, also known as the ABCD matrix, relates the voltage and current at port 1 to those at port 2, whereas the impedance matrix relates the two voltages \( V_1, V_2 \) to the two currents \( I_1, I_2 \):

\[
\begin{bmatrix}
V_1 \\
I_1
\end{bmatrix} =
\begin{bmatrix}
A & B \\
C & D
\end{bmatrix}
\begin{bmatrix}
V_2 \\
I_2
\end{bmatrix}
\]  

(transfer matrix)

\[
\begin{bmatrix}
V_1 \\
V_2
\end{bmatrix} =
\begin{bmatrix}
Z_{11} & Z_{12} \\
Z_{21} & Z_{22}
\end{bmatrix}
\begin{bmatrix}
I_1 \\
-I_2
\end{bmatrix}
\]  

(impedance matrix)

Thus, the transfer and impedance matrices are the \( 2 \times 2 \) matrices:

\[
T = \begin{bmatrix}
A & B \\
C & D
\end{bmatrix}, \\
Z = \begin{bmatrix}
Z_{11} & Z_{12} \\
Z_{21} & Z_{22}
\end{bmatrix}
\]  

(13.1.1)

The admittance matrix is simply the inverse of the impedance matrix, \( Y = Z^{-1} \). The scattering matrix relates the outgoing waves \( b_1, b_2 \) to the incoming waves \( a_1, a_2 \) that are incident on the two-port:

\[
\begin{bmatrix}
b_1 \\
b_2
\end{bmatrix} =
\begin{bmatrix}
S_{11} & S_{12} \\
S_{21} & S_{22}
\end{bmatrix}
\begin{bmatrix}
a_1 \\
a_2
\end{bmatrix}, \\
S = \begin{bmatrix}
S_{11} & S_{12} \\
S_{21} & S_{22}
\end{bmatrix}
\]  

(scattering matrix)  

(13.1.3)

The matrix elements \( S_{11}, S_{12}, S_{21}, S_{22} \) are referred to as the scattering parameters or the S-parameters. The parameters \( S_{11}, S_{22} \) have the meaning of reflection coefficients, and \( S_{21}, S_{12} \), the meaning of transmission coefficients.

The many properties and uses of the S-parameters in applications are discussed in [980–1019]. One particularly nice overview is the HP application note AN-95-1 by Anderson [995] and is available on the web [1354].

We have already seen several examples of transfer, impedance, and scattering matrices. Eq. (10.7.6) or (10.7.7) is an example of a transfer matrix and (10.8.1) is the corresponding impedance matrix. The transfer and scattering matrices of multilayer structures, Eqs. (6.6.23) and (6.6.37), are more complicated examples.

The traveling wave variables \( a_1, b_1 \) at port 1 and \( a_2, b_2 \) at port 2 are defined in terms of \( V_1, I_1 \) and \( V_2, I_2 \) and a real-valued positive reference impedance \( Z_0 \) as follows:

\[
a_1 = \frac{V_1 + Z_0 I_1}{2\sqrt{Z_0}} \\
b_1 = \frac{V_1 - Z_0 I_1}{2\sqrt{Z_0}} \\
a_2 = \frac{V_2 - Z_0 I_2}{2\sqrt{Z_0}} \\
b_2 = \frac{V_2 + Z_0 I_2}{2\sqrt{Z_0}}
\]  

(traveling waves)  

(13.1.4)

The definitions at port 2 appear different from those at port 1, but they are really the same if expressed in terms of the incoming current \(-I_2\):

\[
a_2 = \frac{V_2 - Z_0 I_2}{2\sqrt{Z_0}} = \frac{V_2 + Z_0 (-I_2)}{2\sqrt{Z_0}} \\
b_2 = \frac{V_2 + Z_0 I_2}{2\sqrt{Z_0}} = \frac{V_2 - Z_0 (-I_2)}{2\sqrt{Z_0}}
\]

The term traveling waves is justified below. Eqs. (13.1.4) may be inverted to express the voltages and currents in terms of the wave variables:

\[
V_1 = \sqrt{Z_0} (a_1 + b_1) \\
V_2 = \sqrt{Z_0} (a_2 + b_2) \\
I_1 = \frac{1}{\sqrt{Z_0}} (a_1 - b_1) \\
I_2 = \frac{1}{\sqrt{Z_0}} (b_2 - a_2)
\]  

(13.1.5)

In practice, the reference impedance is chosen to be \( Z_0 = 50 \) ohm. At lower frequencies the transfer and impedance matrices are commonly used, but at microwave frequencies they become difficult to measure and therefore, the scattering matrix description is preferred.

The S-parameters can be measured by embedding the two-port network (the device-under-test, or, DUT) in a transmission line whose ends are connected to a network analyzer. Fig. 13.1.2 shows the experimental setup.

A typical network analyzer can measure S-parameters over a large frequency range, for example, the HP 8720D vector network analyzer covers the range from 50 MHz to
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40 GHz. Frequency resolution is typically 1 Hz and the results can be displayed either on a Smith chart or as a conventional gain versus frequency graph.

\[
\begin{bmatrix}
    a_1 \\ b_1
\end{bmatrix} = \begin{bmatrix}
    e^{-j\delta_1} & 0 \\ 0 & e^{j\delta_2}
\end{bmatrix} \begin{bmatrix}
    a'_1 \\ b'_1
\end{bmatrix}, \quad \begin{bmatrix}
    a_2 \\ b_2
\end{bmatrix} = \begin{bmatrix}
    e^{-j\delta_1} & 0 \\ 0 & e^{j\delta_2}
\end{bmatrix} \begin{bmatrix}
    a'_2 \\ b'_2
\end{bmatrix}
\] (13.1.7)

where \(\delta_1 = \beta l_1\) and \(\delta_2 = \beta l_2\) are the phase lengths of the segments. Eqs. (13.1.7) can be rearranged into the forms:

\[
\begin{bmatrix}
    b_1 \\ b_2
\end{bmatrix} = D \begin{bmatrix}
    b'_1 \\ b'_2
\end{bmatrix}, \quad \begin{bmatrix}
    a_1 \\ a_2
\end{bmatrix} = D \begin{bmatrix}
    a'_1 \\ a'_2
\end{bmatrix}, \quad D = \begin{bmatrix}
    e^{j\delta_1} & 0 \\ 0 & e^{j\delta_2}
\end{bmatrix}
\]

The network analyzer measures the corresponding \(S\)-parameters of the primed variables, that is,

\[
\begin{bmatrix}
    b'_1 \\ b'_2
\end{bmatrix} = \begin{bmatrix}
    S'_{11} & S'_{12} \\ S'_{21} & S'_{22}
\end{bmatrix} \begin{bmatrix}
    a'_1 \\ a'_2
\end{bmatrix}, \quad S' = \begin{bmatrix}
    S'_{11} & S'_{12} \\ S'_{21} & S'_{22}
\end{bmatrix} \quad (\text{measured } S\text{-matrix})
\] (13.1.8)

The \(S\)-matrix of the two-port can be obtained then from:

\[
\begin{bmatrix}
    b_1 \\ b_2
\end{bmatrix} = D \begin{bmatrix}
    b'_1 \\ b'_2
\end{bmatrix} = DS' \begin{bmatrix}
    a'_1 \\ a'_2
\end{bmatrix} = DS'D \begin{bmatrix}
    a_1 \\ a_2
\end{bmatrix} \Rightarrow S = DS'D
\]

or, more explicitly,

\[
\begin{bmatrix}
    S'_{11} & S'_{12} \\ S'_{21} & S'_{22}
\end{bmatrix} = \begin{bmatrix}
    e^{j\delta_1} & 0 \\ 0 & e^{j\delta_2}
\end{bmatrix} \begin{bmatrix}
    S'_{11} & S'_{12} \\ S'_{21} & S'_{22}
\end{bmatrix} \begin{bmatrix}
    e^{j\delta_1} & 0 \\ 0 & e^{j\delta_2}
\end{bmatrix}
\]

(13.1.9)

Thus, changing the points along the transmission lines at which the \(S\)-parameters are measured introduces only phase changes in the parameters.

Without loss of generality, we may replace the extended circuit of Fig. 13.1.3 with the one shown in Fig. 13.1.4 with the understanding that either we are using the extended two-port parameters \(S'\), or, equivalently, the generator and segment \(l_1\) have been replaced by their Thévenin equivalents, and the load impedance has been replaced by its propagated version to distance \(l_2\).

\[
\begin{bmatrix}
    a_1 \\ b_1
\end{bmatrix} = \begin{bmatrix}
    e^{-j\delta_1} & 0 \\ 0 & e^{j\delta_2}
\end{bmatrix} \begin{bmatrix}
    a'_1 \\ b'_1
\end{bmatrix}, \quad \begin{bmatrix}
    a_2 \\ b_2
\end{bmatrix} = \begin{bmatrix}
    e^{-j\delta_1} & 0 \\ 0 & e^{j\delta_2}
\end{bmatrix} \begin{bmatrix}
    a'_2 \\ b'_2
\end{bmatrix}
\] (13.1.7)

The two line segments of lengths \(l_1, l_2\) are assumed to have characteristic impedance equal to the reference impedance \(Z_0\). Then, the wave variables \(a_1, b_1\) and \(a_2, b_2\) are recognized as normalized versions of forward and backward traveling waves. Indeed, according to Eq. (10.7.8), we have:

\[
a_1 = \frac{V_1 + Z_0 I_1}{2\sqrt{Z_0}} = \frac{1}{\sqrt{Z_0}} V_1, \quad a_2 = \frac{V_2 - Z_0 I_2}{2\sqrt{Z_0}} = \frac{1}{\sqrt{Z_0}} V_2,
\]

(13.1.6)

\[
b_1 = \frac{V_1 - Z_0 I_1}{2\sqrt{Z_0}} = \frac{1}{\sqrt{Z_0}} V_1, \quad b_2 = \frac{V_2 + Z_0 I_2}{2\sqrt{Z_0}} = \frac{1}{\sqrt{Z_0}} V_2.
\]

Thus, \(a_1\) is essentially the incident wave at port 1 and \(b_1\) the corresponding reflected wave. Similarly, \(a_2\) is incident from the right onto port 2 and \(b_2\) is the reflected wave from port 2.

The network analyzer measures the waves \(a'_1, b'_1\) and \(a'_2, b'_2\) at the generator and load ends of the line segments, as shown in Fig. 13.1.3. From these, the waves at the inputs of the two-port can be determined. Assuming lossless segments and using the propagation matrices (10.7.7), we have:
The actual measurements of the \( S \)-parameters are made by connecting to a matched load, \( Z_L = Z_0 \). Then, there will be no reflected waves from the load, \( a_2 = 0 \), and the \( S \)-matrix equations will give:

\[
\begin{align*}
b_1 &= S_{11}a_1 + S_{12}a_2 = S_{11}a_1 &\Rightarrow b_1 &= \frac{b_1}{a_1} \bigg|_{Z_L = Z_0} \text{ is reflection coefficient} \\
b_2 &= S_{21}a_1 + S_{22}a_2 = S_{21}a_1 &\Rightarrow b_2 &= \frac{b_2}{a_1} \bigg|_{Z_L = Z_0} \text{ is transmission coefficient}
\end{align*}
\]

Reversing the roles of the generator and load, one can measure in the same way the parameters \( S_{12} \) and \( S_{22} \).

### 13.2 Power Flow

Power flow into and out of the two-port is expressed very simply in terms of the traveling wave amplitudes. Using the inverse relationships (13.1.5), we find:

\[
\begin{align*}
\frac{1}{2} \text{Re}[V^* I_1] &= \frac{1}{2} |a_1|^2 - \frac{1}{2} |b_1|^2 \\
\frac{1}{2} \text{Re}[V^* I_2] &= \frac{1}{2} |a_2|^2 - \frac{1}{2} |b_2|^2
\end{align*}
\]

The left-hand sides represent the power flow into ports 1 and 2. The right-hand sides represent the difference between the power incident on a port and the power reflected from it. The quantity \( \text{Re}[V^* I_2]/2 \) represents the power transferred to the load.

Another way of phrasing these is to say that part of the incident power on a port gets reflected and part enters the port:

\[
\begin{align*}
\frac{1}{2} |a_1|^2 &= \frac{1}{2} |b_1|^2 + \frac{1}{2} \text{Re}[V^* I_1] \\
\frac{1}{2} |a_2|^2 &= \frac{1}{2} |b_2|^2 + \frac{1}{2} \text{Re}[V^* (-I_2)]
\end{align*}
\]

One of the reasons for normalizing the traveling wave amplitudes by \( \sqrt{Z_0} \) in the definitions (13.1.4) was precisely this simple way of expressing the incident and reflected powers from a port.

If the two-port is lossy, the power lost in it will be the difference between the power entering port 1 and the power leaving port 2, that is,

\[
P_{\text{loss}} = \frac{1}{2} \text{Re}[V^* I_1] - \frac{1}{2} \text{Re}[V^* I_2] = \frac{1}{2} |a_1|^2 + \frac{1}{2} |a_2|^2 - \frac{1}{2} |b_1|^2 - \frac{1}{2} |b_2|^2
\]

Noting that \( a^T a = |a_1|^2 + |a_2|^2 \) and \( b^T b = |b_1|^2 + |b_2|^2 \), and writing \( b^T b = a^T S^T S a \), we can express this relationship in terms of the scattering matrix:

\[
P_{\text{loss}} = \frac{1}{2} a^T a - \frac{1}{2} b^T b = \frac{1}{2} a^T a - \frac{1}{2} a^T S^T S a = \frac{1}{2} a^T (I - S^T S) a
\]

For a lossy two-port, the power loss is positive, which implies that the matrix \( I - S^T S \) must be positive definite. If the two-port is lossless, \( P_{\text{loss}} = 0 \), the \( S \)-matrix will be unitary, that is, \( S^T S = I \).

We already saw examples of such unitary scattering matrices in the cases of the equal travel-time multilayer dielectric structures and their equivalent quarter wavelength multisection transformers.

### 13.3 Parameter Conversions

It is straightforward to derive the relationships that allow one to pass from one parameter set to another. For example, starting with the transfer matrix, we have:

\[
\begin{align*}
V_1 &= AV_2 + BI_2 &\Rightarrow V_1 &= A \left( \frac{1}{C} I_1 - \frac{1}{C} I_2 \right) + BI_2 = \frac{A}{C} I_1 - \frac{AD - BC}{C} I_2 \\
I_1 &= CV_2 + DI_2 &\Rightarrow V_2 &= \frac{1}{C} I_1 - \frac{D}{C} I_2
\end{align*}
\]

The coefficients of \( I_1 , I_2 \) are the impedance matrix elements. The steps are reversible, and we summarize the final relationships below:

\[
\begin{align*}
Z &= \begin{bmatrix} Z_{11} & Z_{12} \\ Z_{21} & Z_{22} \end{bmatrix} = \begin{bmatrix} A & AD - BC \\ C & D \end{bmatrix} \\
T &= \begin{bmatrix} A & B \\ C & D \end{bmatrix} = \begin{bmatrix} Z_{11} & Z_{12} Z_{22} - Z_{12} Z_{21} \\ 1 & Z_{22} \end{bmatrix}
\end{align*}
\]

We note the determinants \( \det(T) = AD - BC \) and \( \det(Z) = Z_{11} Z_{22} - Z_{12} Z_{21} \). The relationship between the scattering and impedance matrices is also straightforward to derive. We define the \( 2 \times 1 \) vectors:

\[
V = \begin{bmatrix} V_1 \\ V_2 \end{bmatrix}, \quad I = \begin{bmatrix} I_1 \\ -I_2 \end{bmatrix}, \quad a = \begin{bmatrix} a_1 \\ a_2 \end{bmatrix}, \quad b = \begin{bmatrix} b_1 \\ b_2 \end{bmatrix}
\]

Then, the definitions (13.1.4) can be written compactly as:

\[
\begin{align*}
a &= \frac{1}{2 \sqrt{Z_0}} (V + Z_0 I) = \frac{1}{2 \sqrt{Z_0}} (Z + Z_0 I) I \\
b &= \frac{1}{2 \sqrt{Z_0}} (V - Z_0 I) = \frac{1}{2 \sqrt{Z_0}} (Z - Z_0 I) I
\end{align*}
\]

where we used the impedance matrix relationship \( V = Z I \) and defined the \( 2 \times 2 \) unit matrix \( I \). It follows then,

\[
\frac{1}{2 \sqrt{Z_0}} I = (Z - Z_0 I)^{-1} a \ \Rightarrow \ \ b = \frac{1}{2 \sqrt{Z_0}} (Z - Z_0 I) I = (Z - Z_0 I) (Z + Z_0 I)^{-1} a
\]

Thus, the scattering matrix \( S \) will be related to the impedance matrix \( Z \) by

\[
S = (Z - Z_0 I) (Z + Z_0 I)^{-1} \ \Rightarrow \ \ Z = (I - S)^{-1} (I + S) Z_0
\]
Explicitly, we have:

\[
S = \begin{bmatrix}
Z_{11} - Z_0 & Z_{12} \\
Z_{21} & Z_{22} - Z_0
\end{bmatrix}^{-1}
\]

where \( D_z = \det(Z + Z_0I) = (Z_{11} + Z_0)(Z_{22} + Z_0) - Z_{12}Z_{21} \). Multiplying the matrix factors, we obtain:

\[
S = \frac{1}{D_z} \begin{bmatrix}
(Z_{11} - Z_0)(Z_{22} + Z_0) - Z_{12}Z_{21} \\
2Z_{21}Z_0
\end{bmatrix}^{-1}
\]

Similarly, the inverse relationship gives:

\[
Z = \frac{Z_0}{D_z} \begin{bmatrix}
1 + S_{11} & 1 + S_{12}S_{21} \\
2S_{21}
\end{bmatrix}
\]

where \( D_z = \det(I - S) = (1 - S_{11})(1 - S_{22}) - S_{12}S_{21} \). Expressing the impedance parameters in terms of the transfer matrix parameters, we also find:

\[
S = \frac{1}{D_a} \begin{bmatrix}
A + B/Z_0 - CZ_0 - D & 2(AD - BC) \\
2 & -A + B/Z_0 + CZ_0 + D
\end{bmatrix}
\]

where \( D_a = A + B/Z_0 + CZ_0 + D \).

### 13.4 Input and Output Reflection Coefficients

When the two-port is connected to a generator and load as in Fig. 13.1.4, the impedance and scattering matrix equations take the simpler forms:

\[
V_1 = Z_{in}I_1 \\
V_2 = Z_{L}I_2
\]

where \( Z_{in} \) is the input impedance at port 1, and \( \Gamma_{in}, \Gamma_{L} \) are the reflection coefficients at port 1 and at the load:

\[
\Gamma_{in} = \frac{Z_{in} - Z_0}{Z_{in} + Z_0}, \quad \Gamma_{L} = \frac{Z_L - Z_0}{Z_L + Z_0}
\]

The input impedance and input reflection coefficient can be expressed in terms of the \( Z \) and \( S \)-parameters, as follows:

\[
Z_{in} = \frac{Z_{11} - Z_{12}Z_{21}}{Z_{22} + Z_L} \quad \Gamma_{in} = \frac{S_{12}S_{21}\Gamma_{L}}{1 - S_{22}\Gamma_{L}}
\]

The equivalence of these two expressions can be shown by using the parameter conversion formulas of Eqs. (13.3.5) and (13.3.6), or they can be shown indirectly, as follows. Starting with \( V_2 = Z_{L}I_2 \) and using the second impedance matrix equation, we can solve for \( I_2 \) in terms of \( I_1 \):

\[
V_2 = Z_{21}I_1 - Z_{22}I_2 = Z_{L}I_2 \quad \Rightarrow \quad I_2 = \frac{Z_{21}}{Z_{22} + Z_L}I_1
\]

Then, the first impedance matrix equation implies:

\[
V_1 = Z_{11}I_1 - Z_{12}I_2 = \left( Z_{11} - \frac{Z_{12}Z_{21}}{Z_{22} + Z_L} \right)I_1 = Z_{in}I_1
\]

Starting again with \( V_2 = Z_{L}I_2 \) we find for the traveling waves at port 2:

\[
a_2 = \frac{V_2 - Z_0I_2}{2\sqrt{Z_0}} = \frac{Z_{L} - Z_0}{2\sqrt{Z_0}}I_2 \quad \Rightarrow \quad a_2 = \frac{Z_{L} - Z_0}{Z_L + Z_0}b_2 = \Gamma_{L}b_2
\]

Using \( V_1 = Z_{in}I_1 \), a similar argument implies for the waves at port 1:

\[
a_1 = \frac{V_1 + Z_0I_1}{2\sqrt{Z_0}} = \frac{Z_{in} + Z_0}{2\sqrt{Z_0}}I_1 \quad \Rightarrow \quad a_1 = \frac{Z_{in} - Z_0}{Z_{in} + Z_0}a_1 = \Gamma_{in}a_1
\]

It follows then from the scattering matrix equations that:

\[
b_2 = S_{21}a_1 + S_{22}a_2 = S_{21}a_1 + S_{22}\Gamma_{L}b_2 \quad \Rightarrow \quad b_2 = \frac{S_{21}}{1 - S_{22}\Gamma_{L}}a_1
\]

which implies for \( b_1 \):

\[
b_1 = S_{11}\Gamma_{in} + S_{12}\Gamma_{L} = S_{11}\Gamma_{in} + S_{12}\Gamma_{L}b_2 = \left( S_{11} + \frac{S_{12}S_{21}\Gamma_{L}}{1 - S_{22}\Gamma_{L}} \right)\Gamma_{in}a_1
\]

Reversing the roles of generator and load, we obtain the impedance and reflection coefficients from the output side of the two-port:

\[
Z_{out} = Z_{22} - \frac{Z_{12}Z_{21}}{Z_{11} + Z_C} \quad \Gamma_{out} = \frac{S_{22} + \frac{S_{12}S_{21}\Gamma_{C}}{1 - S_{22}\Gamma_{C}}}{1}
\]

where

\[
\Gamma_{out} = \frac{Z_{out} - Z_0}{Z_{out} + Z_0}, \quad \Gamma_{C} = \frac{Z_C - Z_0}{Z_C + Z_0}
\]

The input and output impedances allow one to replace the original two-port circuit of Fig. 13.1.4 by simpler equivalent circuits. For example, the two-port and the load can be replaced by the input impedance \( Z_{in} \) connected at port 1, as shown in Fig. 13.4.1.
13.5 Stability Circles

In discussing the stability conditions of a two-port in terms of S-parameters, the following definitions of constants are often used:

\[ \Delta = \det(S) = S_{11}S_{22} - S_{12}S_{21} \]

\[ K = \frac{1 - |S_{11}|^2 - |S_{22}|^2 - |\Delta|^2}{2|S_{12}S_{21}|} \quad (\text{Rollott stability factor}) \]

\[ \mu_1 = \frac{1 - |S_{11}|^2}{|S_{22} - \Delta S_{11}^{-1}|} \quad (\text{Edwards-Sinsky stability parameter}) \]

\[ \mu_2 = \frac{1 - |S_{22}|^2}{|S_{11} - \Delta S_{22}^{-1}|} \]

\[ B_1 = 1 + |S_{11}|^2 - |S_{22}|^2 - |\Delta|^2 \]

\[ B_2 = 1 + |S_{22}|^2 - |S_{11}|^2 - |\Delta|^2 \]

\[ C_1 = S_{11} - \Delta S_{22}^{-1}, \quad D_1 = |S_{11}|^2 - |\Delta|^2 \]

\[ C_2 = S_{22} - \Delta S_{11}^{-1}, \quad D_2 = |S_{22}|^2 - |\Delta|^2 \]

The quantity \( K \) is the Rollott stability factor [991], and \( \mu_1, \mu_2 \), the Edwards-Sinsky stability parameters [994]. The following identities hold among these constants:

\[ B_1^2 - 4|C_1|^2 = B_2^2 - 4|C_2|^2 = 4|S_{12}S_{21}|^2(K^2 - 1) \]

\[ |C_1|^2 = |S_{12}S_{21}|^2 + (1 - |S_{22}|^2)D_1 \]

\[ |C_2|^2 = |S_{12}S_{21}|^2 + (1 - |S_{11}|^2)D_2 \]

For example, noting that \( S_{12}S_{21} = S_{11}S_{22} - \Delta \), the last of Eqs. (13.5.2) is a direct consequence of the identity:

\[ |A - BC|^2 - |B - AC*|^2 = (1 - |C|^2)(|A|^2 - |B|^2) \quad (13.5.3) \]

We define also the following parameters, which will be recognized as the centers and radii of the source and load stability circles:

\[ c_G = \frac{C_{1}^*}{D_1}, \quad r_G = \frac{|S_{12}S_{21}|}{|D_1|} \quad (\text{source stability circle}) \]

\[ c_L = \frac{C_{2}^*}{D_2}, \quad r_L = \frac{|S_{12}S_{21}|}{|D_2|} \quad (\text{load stability circle}) \]

They satisfy the following relationships, which are consequences of the last two of Eqs. (13.5.2) and the definitions (13.5.4) and (13.5.5):

\[ 1 - |S_{11}|^2 = (|c_L|^2 - r_L^2)D_2 \]

\[ 1 - |S_{22}|^2 = (|c_G|^2 - r_G^2)D_1 \]

\[ 1 - |S_{11}|^2 = (|c_L|^2 - r_L^2)\text{sign}(D_2) \quad (13.5.6) \]

\[ 1 - |S_{22}|^2 = (|c_G|^2 - r_G^2)\text{sign}(D_1) \]

\[ \mu_1 = (|c_L| - r_L)\text{sign}(D_2) \]

\[ \mu_2 = (|c_G| - r_G)\text{sign}(D_1) \]

For example, we have:

\[ \mu_1 = \frac{1 - |S_{11}|^2}{|C_2| + |S_{12}S_{21}|} = \frac{D_2(|c_L|^2 - r_L^2)}{|D_2||C_2| + |D_2||r_L|} = \frac{D_2(|c_L|^2 - r_L^2)}{|D_2||C_2| + |r_L|} = \frac{D_2(|c_L|^2 - r_L^2)}{|D_2|} \]

\[ \mu_2 = (|c_G| - r_G)\text{sign}(D_1) \]

We note also that using Eqs. (13.5.6), the stability parameters \( \mu_1, \mu_2 \) can be written as:

\[ \mu_1 = (|c_L| - r_L)\text{sign}(D_2) \]

\[ \mu_2 = (|c_G| - r_G)\text{sign}(D_1) \]

Next, we discuss the stability conditions. The two-port is unconditionally stable if any generator and load impedances with positive resistive parts \( R_G, R_L \), will always lead to input and output impedances with positive resistive parts \( R_{in}, R_{out} \).

Equivalently, unconditional stability requires that any load and generator with \( |G_L| < 1 \) and \( |G_G| < 1 \) will result into \( |I_{in}| < 1 \) and \( |I_{out}| < 1 \).

The two-port is termed potentially or conditionally unstable if there are \( |G_L| < 1 \) and \( |G_G| < 1 \) resulting into \( |I_{in}| \geq 1 \) and/or \( |I_{out}| \geq 1 \).

The load stability region is the set of all \( G_L \) that result into \( |I_{in}| < 1 \), and the source stability region, the set of all \( G_G \) that result into \( |I_{out}| < 1 \).

In the unconditionally stable case, the load and source stability regions contain the entire unit-circles \( |I_{L}| < 1 \) or \( |I_{G}| < 1 \). However, in the potentially unstable case, only
portions of the unit-circles may lie within the stability regions and such \( r_G, r_L \) will lead to a stable input and output impedances.

The connection of the stability regions to the stability circles is brought about by the following identities, which can be proved easily using Eqs. (13.5.1)–(13.5.8):

\[
1 - |I_{in}|^2 = \frac{|r_G - c_L|^2 - r_L^2}{|1 - S_{22}|^2} D_2
\]

(13.5.9)

\[
1 - |I_{out}|^2 = \frac{|r_G - c_G|^2 - r_L^2}{|1 - S_{11}|^2} D_1
\]

For example, the first can be shown starting with Eq. (13.5.8) and using the definitions (13.5.5) and the relationship (13.5.6):

\[
1 - |I_{in}|^2 = 1 - \left( \frac{|S_{11} - \Delta F_L|}{1 - S_{22} F_L} \right)^2 = \frac{|S_{11} - \Delta F_L|^2 - |1 - S_{22} F_L|^2}{|1 - S_{22} F_L|^2}
\]

\[
= \frac{(|S_{22}|^2 - |\Delta|^2) |F_L|^2 - (S_{22} - S_{S1}) G_L - (S_{S2} - S_{S1}) G_L^2 + 1 - |S_{11}|^2}{|1 - S_{22} F_L|^2}
\]

\[
= \frac{D_2 |F_L|^2 - C_2 F_L + C_2^* F_L^*}{|1 - S_{22} F_L|^2} + 1 - |S_{11}|^2
\]

(13.5.10)

It follows from Eq. (13.5.9) that the load stability region is defined by the conditions:

\[
1 - |I_{in}|^2 > 0 \quad \Leftrightarrow \quad (|F_L - c_L|^2 - r_L^2) D_2 > 0
\]

Depending on the sign of \( D_2 \), these are equivalent to the outside or the inside of the load stability circle of center \( c_L \) and radius \( r_L \):

\[
\begin{align*}
|F_L - c_L| > r_L, & \quad \text{if } D_2 > 0 \\
|F_L - c_L| < r_L, & \quad \text{if } D_2 < 0
\end{align*}
\]

(13.5.11)

The boundary of the circle \( |F_L - c_L| = r_L \) corresponds to \( |I_{in}| = 1 \). The complement of these regions corresponds to the unstable region with \( |I_{in}| > 1 \). Similarly, we find for the source stability region:

\[
\begin{align*}
|F_G - c_G| > r_G, & \quad \text{if } D_1 > 0 \\
|F_G - c_G| < r_G, & \quad \text{if } D_1 < 0
\end{align*}
\]

(13.5.12)

In order to have unconditional stability, the stability regions must contain the unit-circle in its entirety. If \( D_2 > 0 \), the unit-circle and load stability circle must not overlap at all, as shown in Fig. 13.5.1. Geometrically, the distance between the points \( O \) and \( A \) in the figure is \( |O A| = |c_L| - r_L \). The non-overlapping of the circles requires the condition \( |O A| > 1 \), or, \(|c_L| - r_L > 1 \).

If \( D_2 < 0 \), the stability region is the inside of the stability circle, and therefore, the unit-circle must lie within this circle. This requires that \( |O A| = r_L - |c_L| > 1 \), as shown in Fig. 13.5.1.

These two conditions can be combined into sign \( D_2 \) \(|c_L| - r_L \) > 1. But, that is equivalent to \( \mu_1 > 1 \) according to Eq. (13.5.7). Geometrically, the parameter \( \mu_1 \) represents the distance \( (O A) \). Thus, the condition for the unconditional stability of the input is equivalent to:

\[
\mu_1 > 1 \quad \text{(unconditional stability condition)}
\]

(13.5.13)

It has been shown by Edwards and Sinsky [994] that this single condition (or, alternatively, the single condition \( \mu_2 > 1 \)) is necessary and sufficient for the unconditional stability of both the input and output impedances of the two-port. Clearly, the source stability regions will be similar to those of Fig. 13.5.1.

If the stability condition is not satisfied, that is, \( \mu_1 < 1 \), then only that portion of the unit-circle that lies within the stability region will be stable and will lead to stable input and output impedances. Fig. 13.5.2 illustrates such a potentially unstable case.

If \( D_2 > 0 \), then \( \mu_1 < 1 \) is equivalent to \(|c_L| - r_L < 1 \), and if \( D_2 < 0 \), it is equivalent to \( r_L - |c_L| < 1 \). In either case, the unit-circle is partially overlapping with the stability
circle, as shown in Fig. 13.5.2. The portion of the unit-circle that does not lie within the stability region will correspond to an unstable $Z_{in}$.

There exist several other unconditional stability criteria that are equivalent to the single criterion $\mu_1 > 1$. They all require that the Rollett stability factor $K$ be greater than unity, $K > 1$, as well as one other condition. Any one of the following criteria are necessary and sufficient for unconditional stability [992]:

\[
K > 1 \quad \text{and} \quad |\Delta| < 1 \\
K > 1 \quad \text{and} \quad B_1 > 0 \\
K > 1 \quad \text{and} \quad B_2 > 0 \\
K > 1 \quad \text{and} \quad |S_{12}S_{21}| < 1 - |S_{11}|^2 \\
K > 1 \quad \text{and} \quad |S_{12}S_{21}| < 1 - |S_{22}|^2
\]  

(stability conditions) (13.5.13)

Their equivalence to $\mu_1 > 1$ has been shown in [994]. In particular, it follows from the last two conditions that unconditional stability requires $|S_{11}| < 1$ and $|S_{22}| < 1$. These are necessary but not sufficient for stability.

A very common circumstance in practice is to have a potentially unstable two-port, but with $|S_{11}| < 1$ and $|S_{22}| < 1$. In such cases, Eq. (13.5.6) implies $D_2(|c_{L}|^2 - r_1^2) > 0$, and the lack of stability requires $\mu_1 = \text{sign}(D_2)\left(|c_{L}|^2 - r_1^2\right) < 1$.

Therefore, if $D_2 > 0$, then we must have $|c_{L}|^2 > r_1^2 > 0$ and $|c_{L}| - r_1 < 1$, which combine into the inequality $r_1 < |c_{L}| < r_1 + 1$. This is depicted in the left picture of Fig. 13.5.2. The geometrical distance $(OA) = |c_{L}| - r_1$ satisfies $0 < (OA) < 1$, so that stability circle partially overlaps with the unit-circle but does not enclose its center.

On the other hand, if $D_2 < 0$, the two conditions require $|c_{L}|^2 - r_1^2 < 0$ and $r_1 - |c_{L}| < 1$, which imply $|c_{L}| < r_1 < |c_{L}| + 1$. This is depicted in the right Fig. 13.5.2. The geometrical distance $(OA) = r_1 - |c_{L}|$ again satisfies $0 < (OA) < 1$, but now the center of the unit-circle lies within the stability circle, which is also the stability region.

We have written a number of MATLAB functions that facilitate working with $S$-parameters. They are described in detail later on:

```matlab
smat
sparam
span
smith
smithcir
gin,gout
sgcirc
smth
nfig
nfcirc
```

The MATLAB function `spare` calculates the stability parameters $\mu_1, K, |\Delta|, B_1, B_2$, as well as the parameters $C_1, C_2, D_1, D_2$. It has usage:

\[
[K,\mu,D,B1,B2,C1,C2,D1,D2] = \text{spare}(S); \quad \% \text{stability parameters}
\]

The function `sgcirc` calculates the centers and radii of the source and load stability circles. It also calculates gain circles to be discussed later on. Its usage is:

\[
[cl,rl] = \text{sgcirc}(S,'l'); \quad \% \text{load or } Z_{in} \text{ stability circle}
\]

\[
[cg,rg] = \text{sgcirc}(S,'s'); \quad \% \text{source or } Z_{out} \text{ stability circle}
\]

The MATLAB function `smith` draws a basic Smith chart, and the function `smithcir` draws the stability circles:

\[
\text{smith}(n); \quad \% \text{draw four basic types of Smith charts, } n = 1, 2, 3, 4
\]

\[
\text{smith; } \quad \% \text{default Smith chart corresponding to } n = 3
\]

\[
\text{smithcir(c,r,max,width);} \quad \% \text{draw circle of center } c \text{ and radius } r
\]

\[
\text{smithcir(c,r,max);} \quad \% \text{equivalent to linewidth width=1}
\]

\[
\text{smithcir(c,r);} \quad \% \text{draw full circle with linewidth width=1}
\]

The parameter `max` controls the portion of the stability circle that is visible outside the Smith chart. For example, `max = 1.1` will display only that portion of the circle that has $|F| < 1.1$.

**Example 13.5.1:** The Hewlett-Packard AT-41511 NPN bipolar transistor has the following $S$-parameters at 1 GHz and 2 GHz [1355]:

\[
S_{11} = 0.48 \angle -149^\circ, \quad S_{12} = 5.189 \angle 89^\circ, \quad S_{21} = 0.073 \angle 43^\circ, \quad S_{22} = 0.49 \angle -39^\circ
\]

\[
S_{11} = 0.46 \angle 162^\circ, \quad S_{12} = 2.774 \angle 59^\circ, \quad S_{21} = 0.103 \angle 45^\circ, \quad S_{22} = 0.42 \angle -47^\circ
\]

Determine the stability parameters, stability circles, and stability regions.

**Solution:** The transistor is potentially unstable at 1 GHz, but unconditionally stable at 2 GHz.

The source and load stability circles at 1 GHz are shown in Fig. 13.5.3.

![Fig. 13.5.3 Load and source stability circles at 1 GHz.](image)

The MATLAB code used to generate this graph was:

```matlab
S = smat([0.48 -149 5.189 89 0.073 43 0.49 -39]); \% form S-matrix
[K,\mu,D,B1,B2,C1,C2,D1,D2] = \text{spare}(S); \% stability parameters
[cl,rl] = \text{sgcirc}(S,'l'); \% stability circles
[cg,rg] = \text{sgcirc}(S,'s');
\text{smith;}
\text{smithcir(cl, rl, 1.1, 1.5);}
\text{smithcir(cg, rg, 1.1, 1.5);}
```
13.6 Power Gains

The computed stability parameters at 1 GHz were:

\[ [K, \mu_1, |\Delta|, B_1, B_2, D_1, D_2] = [0.781, 0.847, 0.250, 0.928, 0.947, 0.168, 0.178] \]

The transistor is potentially unstable because \( K < 1 \) even though \( |\Delta| < 1, B_1 > 0, \) and \( B_2 > 0. \) The load and source stability circle centers and radii were:

\[
\begin{align*}
c_L &= 2.978 \angle 51.75^\circ, \quad r_L = 2.131 \\
c_G &= 3.098 \angle 162.24^\circ, \quad r_G = 2.254
\end{align*}
\]

Because both \( D_1 \) and \( D_2 \) are positive, both stability regions will be the portion of the Smith chart that lies outside the stability circles. For 2 GHz, we find:

\[ [K, \mu_1, |\Delta|, B_1, B_2, D_1, D_2] = [1.089, 1.056, 0.103, 1.025, 0.954, 0.201, 0.166] \]

\[
\begin{align*}
c_L &= 2.779 \angle 50.12^\circ, \quad r_L = 1.723 \\
c_G &= 2.473 \angle -159.36^\circ, \quad r_G = 1.421
\end{align*}
\]

The transistor is stable at 2 GHz, with both load and source stability circles being completely outside the unit-circle. \( \square \)

Problem 13.2 presents an example for which the \( D_2 \) parameter is negative, so that the stability regions will be the inside of the stability circles. At one frequency, the unit-circle is partially overlapping with the stability circle, while at another frequency, it lies entirely within the stability circle.

The amplification (or attenuation) properties of the two-port can be deduced by comparing the power \( P_m \) going into the two-port to the power \( P_L \) coming out of the two-port and going into the load. These were given in Eq. (13.2.1) and we rewrite them as:

\[
\begin{align*}
P_m &= \frac{1}{2} \text{Re}[V_I^* I_1] = \frac{1}{2} R_m |I_1|^2 \quad \text{(power into two-port)} \\
P_L &= \frac{1}{2} \text{Re}[V_L^* I_2] = \frac{1}{2} R_L |I_2|^2 \quad \text{(power out of two-port and into load)}
\end{align*}
\]

where we used \( V_I = Z_m I_1, \) \( V_L = Z_L I_2, \) and defined the real parts of the input and load impedances by \( R_m = \text{Re}(Z_m) \) and \( R_L = \text{Re}(Z_L). \) Using the equivalent circuits of Fig. 13.4.1, we may write \( I_1, I_2 \) in terms of the generator voltage \( V_G \) and obtain:

\[
\begin{align*}
P_m &= \frac{1}{2} \frac{|V_G|^2 R_m}{|Z_m + Z_G|^2} \left(1 - |\Gamma_m|^2\right) \left(1 - |\Gamma_G|^2\right) \\
P_L &= \frac{1}{2} \frac{|V_L|^2 R_L}{|Z_out + Z_L|^2} \left(1 - |\Gamma_L|^2\right) \left(1 - |\Gamma_G|^2\right)
\end{align*}
\]

(13.6.2)

Using the identities of Problem 13.1, \( P_L \) can also be written in the alternative forms:

\[
P_L = \frac{1}{2} \frac{|V_G|^2 R_L |Z_{21}|^2}{|Z_{22} + Z_L (Z_{in} + Z_G)|^2} = \frac{1}{2} \frac{|V_G|^2 R_L |Z_{21}|^2}{|Z_{11} + Z_G (Z_{22} + Z_L) - Z_{12} Z_{21}|^2}
\]

(13.6.3)

The maximum power that can be delivered by the generator to a connected load is called the available power of the generator, \( P_{avG}, \) and is obtained when the load is conjugate-matched to the generator, that is, \( P_{avG} = P_m \) when \( Z_{in} = Z_G^\ast. \)

Similarly, the available power from the two-port network, \( P_{avN}, \) is the maximum power that can be delivered by the Thévenin-equivalent circuit of Fig. 13.4.1 to a connected load, that is, \( P_{avN} = P_L \) when \( Z_L = Z_{out}^\ast = Z_G^\ast. \) It follows then from Eq. (13.6.2) that the available powers will be:

\[
P_{avG} = \text{max} P_m = \frac{|V_G|^2}{8R_G} \quad \text{(available power from generator)}
\]

(13.6.4)

\[
P_{avN} = \text{max} P_L = \frac{|V_{th}|^2}{8R_{out}} \quad \text{(available power from network)}
\]

Using Eq. (13.4.8), \( P_{avN} \) can also be written as:

\[
P_{avN} = \frac{|V_G|^2}{8R_{out}} \left| \frac{Z_{21}}{Z_{11} + Z_G} \right|^2
\]

(13.6.5)

The powers can be expressed completely in terms of the S-parameters of the two-port and the input and output reflection coefficients. With the help of the identities of Problem 13.1, we find the alternative expressions for \( P_m \) and \( P_L: \)

\[
P_m = \frac{|V_G|^2}{8Z_0} \left(1 - |\Gamma_m|^2\right) \left(1 - |\Gamma_G|^2\right)
\]

(13.6.6)

\[
P_L = \frac{|V_G|^2}{8Z_0} \left(1 - |\Gamma_L|^2\right) \left(1 - |\Gamma_G|^2\right) |S_{21}|^2
\]

(13.6.7)

Similarly, we have for \( P_{avG} \) and \( P_{avN}: \)

\[
P_{avG} = \frac{|V_G|^2}{8Z_0} \left(1 - |\Gamma_G|^2\right)
\]

(13.6.8)

\[
P_{avN} = \frac{|V_G|^2}{8Z_0} \left(1 - |\Gamma_G|^2\right) |S_{21}|^2
\]

(13.6.9)

It is evident that \( P_{avG}, P_{avN}\) are obtained from \( P_m, P_L \) by setting \( \Gamma_m = \Gamma_G^\ast \) and \( \Gamma_L = \Gamma_{out}^\ast, \) which are equivalent to the conjugate-match conditions.
Three widely used definitions for the power gain of the two-port network are the transducer power gain $G_T$, the available power gain $G_a$, and the power gain $G_p$, also called the operating gain. They are defined as follows:

$$G_T = \frac{\text{power out of network}}{\text{maximum power in}} = \frac{P_L}{P_{\text{avg}}},$$  
(transducer power gain)

$$G_a = \frac{\text{maximum power out}}{\text{maximum power in}} = \frac{P_{\text{avN}}}{P_{\text{avg}}},$$  
(available power gain) \hspace{1cm} (13.6.8)

$$G_p = \frac{\text{power out of network}}{\text{power into network}} = \frac{P_L}{P_{\text{in}}},$$  
(operating power gain)

Each gain is expressible either in terms of the $Z$-parameters of the two-port, or in terms of its $S$-parameters. In terms of $Z$-parameters, the transducer gain is given by the following forms, obtained from the three forms of $P_L$ in Eqs. (13.6.2) and (13.6.3):

$$G_T = \frac{4R_GR_L|Z_{21}|^2}{|(Z_{22} + Z_L)(Z_{in} + Z_G)|^2} = \frac{4R_GR_L|Z_{21}|^2}{|(Z_{11} + Z_G)(Z_{out} + Z_L)|^2} \hspace{1cm} (13.6.9)$$

And, in terms of the $S$-parameters:

$$G_T = \frac{1 - |\Gamma_G|^2}{\frac{1}{1 - S_{11}\Gamma_G}S_{21}^2 - \frac{1}{1 - S_{22}\Gamma_L}1} = \frac{1 - |\Gamma_G|^2}{\frac{1}{1 - S_{11}\Gamma_G}S_{21}^2 - \frac{1}{1 - S_{22}\Gamma_L}1} \hspace{1cm} (13.6.10)$$

Similarly, we have for $G_a$ and $G_p$:

$$G_a = \frac{R_G}{R_{\text{out}}} \frac{|Z_{21}|^2}{Z_{11} + Z_G} = \frac{1 - |\Gamma_G|^2}{\frac{1}{1 - S_{11}\Gamma_G}S_{21}^2 - \frac{1}{1 - S_{22}\Gamma_L}1} \hspace{1cm} (13.6.11)$$

The transducer gain $G_T$ is, perhaps, the most representative measure of gain for the two-port because it incorporates the effects of both the load and generator impedances, whereas $G_a$ depends only on the generator impedance and $G_p$ only on the load impedance.

If the generator and load impedances are matched to the reference impedance $Z_0$, so that $Z_G = Z_L = Z_0$ and $\Gamma_G = \Gamma_L = 0$, and $\Gamma_{\text{in}} = S_{11}, \Gamma_{\text{out}} = S_{22}$, then the power gains reduce to:

$$G_T = |S_{21}|^2, \quad G_a = \frac{|S_{21}|^2}{1 - |S_{22}|^2}, \quad G_p = \frac{|S_{21}|^2}{1 - |S_{11}|^2}$$  
(13.6.12)

A unilateral two-port has by definition zero reverse transmission coefficient, that is, $S_{12} = 0$. In this case, the input and output reflection coefficients simplify into:

$$\Gamma_{\text{in}} = S_{11}, \quad \Gamma_{\text{out}} = S_{22}$$  
(unilateral two-port) \hspace{1cm} (13.6.13)

The expressions of the power gains simplify somewhat in this case:

$$G_T = \frac{1 - |\Gamma_G|^2}{\frac{1}{1 - S_{11}\Gamma_G}S_{21}^2 - \frac{1}{1 - S_{22}\Gamma_L}1}$$

$$G_a = \frac{1 - |\Gamma_G|^2}{\frac{1}{1 - S_{11}\Gamma_G}S_{21}^2 - \frac{1}{1 - S_{22}\Gamma_L}1}$$  
(unilateral gains) \hspace{1cm} (13.6.14)

$$G_p = \frac{1}{\frac{1}{1 - S_{11}}|S_{21}|^2 - \frac{1}{1 - S_{22}\Gamma_L}1}$$

For both the bilateral and unilateral cases, the gains $G_a, G_p$ are obtainable from $G_T$ by setting $\Gamma_L = \Gamma_{\text{out}}^*$ and $\Gamma_{\text{in}} = \Gamma_G^*$, respectively, as was the case for $P_{\text{avN}}$ and $P_{\text{avg}}$.

The relative power ratios $P_{\text{in}}/P_{\text{avg}}$ and $P_L/P_{\text{avN}}$ measure the mismatching between the generator and the two-port and between the load and the two-port. Using the definitions for the power gains, we obtain the input and output mismatch factors:

$$M_{\text{in}} = \frac{P_{\text{in}}}{P_{\text{avg}}} = \frac{G_T}{G_p} = \frac{4R_GR_L}{Z_{in} + Z_G} = \frac{1 - |\Gamma_{\text{in}}|^2}{\frac{1}{1 - S_{11}\Gamma_G}S_{21}^2 - \frac{1}{1 - S_{22}\Gamma_L}1}$$  
(13.6.15)

$$M_{\text{out}} = \frac{P_L}{P_{\text{avN}}} = \frac{G_a}{G_T} = \frac{4R_{\text{out}}R_L}{|Z_{out} + Z_L|^2} = \frac{1 - |\Gamma_{\text{out}}|^2}{\frac{1}{1 - S_{11}\Gamma_G}S_{21}^2 - \frac{1}{1 - S_{22}\Gamma_L}1}$$  
(13.6.16)

The mismatch factors are always less than or equal to unity (for positive $R_{\text{in}}$ and $R_{\text{out}}$). Clearly, $M_{\text{in}} = 1$ under the conjugate-match condition $Z_{\text{in}} = Z_G^*$ or $\Gamma_{\text{in}} = \Gamma_G^*$, and $M_{\text{out}} = 1$ if $Z_{\text{out}} = Z_L^*$ or $\Gamma_{\text{out}} = \Gamma_L^*$. The mismatch factors can also be written in the following forms, which show more explicitly the mismatch properties:

$$M_{\text{in}} = 1 - \frac{\Gamma_{\text{in}} - \Gamma_{\text{in}}^*}{\Gamma_G} \Gamma_{\text{in}}^* = 1 - \frac{\Gamma_{\text{out}} - \Gamma_{\text{in}}^*}{1 - \Gamma_{\text{out}}^*} \Gamma_{\text{in}}^*$$  
(13.6.17)
Simultaneous matching is discussed in Sec. 13.8. The necessary and sufficient condition for simultaneous matching is \( K \geq 1 \), where \( K \) is the Rollett stability factor. It can be shown that the MAG can be expressed as:

\[
G_{MAG} = \frac{|S_{21}|^2}{|S_{12}|^2} (K - \sqrt{K^2 - 1})
\]  

(maximum available gain) (13.6.20)

The maximum stable gain (MSG) is the maximum value \( G_{MAG} \) can have, which is achievable when \( K = 1 \):

\[
G_{MSG} = \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \quad (maximum \ stable \ gain) \]  

(13.6.21)

In the unilateral case, the MAG is obtained either by setting \( \Gamma_G = \Gamma_{in} = S_{11}^* \) and \( \Gamma_L = \Gamma_{out} = S_{22}^* \) in Eq. (13.6.14), or by a careful limiting process in Eq. (13.6.20), in which \( K \to \infty \) so that both the numerator factor \( K - \sqrt{K^2 - 1} \) and the denominator factor \( |S_{12}|^2 \) tend to zero. With either method, we find the unilateral MAG:

\[
G_{MAG,u} = \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} = G_1 |S_{21}|^2 G_2 \quad (unilateral \ MAG) \]  

(13.6.22)

The maximum unilateral input and output gain factors are:

\[
G_1 = \frac{1}{1 - |S_{11}|^2}, \quad G_2 = \frac{1}{1 - |S_{22}|^2}
\]  

(13.6.23)

They are the maxima of the input and output gain factors in Eq. (13.6.14) realized with conjugate matching, that is, with \( \Gamma_G = S_{11}^* \) and \( \Gamma_L = S_{22}^* \). For any other values of the reflection coefficients (such that \( |\Gamma_G| < 1 \) and \( |\Gamma_L| < 1 \), we have the following inequalities, which follow from the identity (13.6.18):

\[
\frac{1 - |\Gamma_G|^2}{1 - |S_{11}|^2 |\Gamma_G|^2} \leq \frac{1}{1 - |S_{11}|^2}, \quad \frac{1 - |\Gamma_L|^2}{1 - |S_{22}| |\Gamma_L|^2} \leq \frac{1}{1 - |S_{22}|^2}
\]  

(13.6.24)

Often two-ports, such as most microwave transistor amplifiers, are approximately unilateral, that is, the measured \( S \)-parameters satisfy \( |S_{12}| \ll |S_{21}| \). To decide whether the two-port should be treated as unilateral, a figure of merit is used, which is essentially the comparison of the maximum unilateral gain to the transducer gain of the actual device under the same matching conditions, that is, \( \Gamma_G = S_{11}^* \) and \( \Gamma_L = S_{22}^* \).

For these matched values of \( \Gamma_G, \Gamma_L \), the ratio of the bilateral and unilateral transistor gains can be shown to have the form:

\[
g_u = \frac{G_T}{G_{Tu}} = \frac{1}{1 - |U|^2}, \quad U = \frac{S_{12}S_{21}S_{11}^*S_{22}^*}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \]  

(13.6.25)

The quantity \( |U| \) is known as the unilateral figure of merit. If the relative gain ratio \( g_u \) is near unity (typically, within 10 percent of unity), the two-port may be treated as unilateral.

The MATLAB function \( \text{sgain} \) computes the transducer, available, and operating power gains, given the \( S \)-parameters and the reflection coefficients \( \Gamma_G, \Gamma_L \). In addition, it computes the unilateral gains, the maximum available gain, and the maximum stable gain. It also computes the unilateral figure of merit ratio (13.6.25). It has usage:

- \( G_T = \text{sgain}(S, g_G, g_L) \): transducer power gain at given \( \Gamma_G, \Gamma_L \)
- \( G_a = \text{sgain}(S, g_G, \cdot g_L) \): available power gain at given \( \Gamma_G, \Gamma_L \) with \( \Gamma_G = \Gamma_{out} \)
- \( G_p = \text{sgain}(S, g_G, g_L) \): operating power gain at given \( \Gamma_G, \Gamma_L \) with \( \Gamma_G = \Gamma_{in} \)
- \( G_{mag} = \text{sgain}(S) \): maximum available gain (MAG)
- \( G_{msg} = \text{sgain}(S, \cdot \text{msg}) \): maximum stable gain (MSG)
- \( G_u = \text{sgain}(S, \cdot u) \): maximum unilateral gain, Eq. (13.6.22)
- \( G_l = \text{sgain}(S, \cdot \text{ufm}) \): maximum unilateral input gain, Eq. (13.6.23)
- \( G_2 = \text{sgain}(S, \cdot u_0) \): maximum unilateral output gain, Eq. (13.6.23)
- \( g_u = \text{sgain}(S, \cdot \text{ufm}) \): unilateral figure of merit ratio, Eq. (13.6.25)

The MATLAB functions \( \text{gout} \) and \( \text{gin} \) compute the input and output reflection coefficients from \( S \) and \( \Gamma_G, \Gamma_L \). They have usage:

- \( \text{Gin} = \text{gin}(S, g_G) \): input reflection coefficient, Eq. (13.4.3)
- \( \text{Gout} = \text{gout}(S, g_G) \): output reflection coefficient, Eq. (13.4.6)

**Example 13.6.1:** A microwave transistor amplifier uses the Hewlett-Packard AT-41410 NPN bipolar transistor with the following \( S \)-parameters at 2 GHz [1355]:

\[
S_{11} = 0.61 \angle 165^\circ, \quad S_{21} = 3.72 \angle 59^\circ, \quad S_{12} = 0.05 \angle 42^\circ, \quad S_{22} = 0.45 \angle -48^\circ
\]

Calculate the input and output reflection coefficients and the various power gains, if the amplifier is connected to a generator and load with impedances \( Z_G = 10 - 20j \) and \( Z_L = 30 + 40j \) ohm.

**Solution:** The following MATLAB code will calculate all the required gains:

```matlab
Z0 = 50; \ % normalization impedance
ZG = 10+20j; \ gG = z2g(ZG,Z0); \ % \text{gG} = -0.50 \pm 0.50j = 0.71 \angle 135^\circ
ZL = 30+40j; \ gl = z2g(ZL,Z0); \ % \text{gl} = -0.41 \pm 0.43j = 0.59 \angle -133.15^\circ
S = smat([0.61 165 3.72 59 0.05 42 0.45 -48]); \ % reshape \text{S} into matrix
Gin = gin(S, gG); \ % \text{Gin} = 0.54\angle 162.30^\circ
Gout = gout(S, gG); \ % \text{Gout} = 0.45\angle -67.46^\circ
Gt = sgain(S, gG, gl); \ % \text{Gt} = 4.71, or, 6.73 dB
Ga = sgain(S, gG, gL); \ % \text{Ga} = 11.44, or, 10.58 dB
Gp = sgain(S, gG, gL); \ % \text{Gp} = 10.51, or, 10.22 dB
Gu = sgain(S, \cdot u); \ % \text{Gu} = 27.64, or, 14.41 dB
G1 = sgain(S, \cdot u1); \ % \text{G1} = 1.39, or, 2.02 dB
G2 = sgain(S, \cdot u0); \ % \text{G2} = 1.25, or, 0.98 dB
gu = sgain(S, \cdot u'f); \ % \text{gu} = 1.23, or, 0.89 dB
Gmag = sgain(S); \ % \text{Gmag} = 41.50, or, 16.18 dB
Gmsg = sgain(S, \cdot \text{msg}); \ % \text{Gmsg} = 74.40, or, 18.72 dB
```
13.7 Generalized S-Parameters and Power Waves

The amplifier cannot be considered to be unilateral as the unilateral figure of merit ratio \( g_u = 1.23 \) is fairly large (larger than 10 percent from unity.)

The amplifier is operating at a gain of \( G_T = 6.73 \) dB, which is far from the maximum value of \( G_{MAX} = 16.18 \) dB. This is because it is mismatched with the given generator and load impedances.

To realize the optimum gain \( G_{MAX} \) the amplifier must 'see' certain optimum generator and load impedances or reflection coefficients. These can be calculated by the MATLAB function \textsc{snatch} and are found to be:

\[
\Gamma_G = 0.82 \angle -162.67^\circ \quad \Rightarrow \quad Z_G = g2z(Z_G, Z_0) = 5.12 - 7.54 j \Omega
\]

\[
\Gamma_L = 0.75 \angle 52.57^\circ \quad \Rightarrow \quad Z_L = g2z(Z_L, Z_0) = 33.66 + 91.48 j \Omega
\]

The design of such optimum matching terminations and the function \textsc{snatch} are discussed in Sec. 13.8. The functions \( g2z \) and \( z2g \) were discussed in Sec. 10.7 .

### 13.7 Generalized S-Parameters and Power Waves

The practical usefulness of the S-parameters lies in the fact that the definitions (13.1.4) represent forward and backward traveling waves, which can be measured remotely by connecting a network analyzer to the two-port with transmission lines of characteristic impedance equal to the normalization impedance \( Z_0 \). This was depicted in Fig. 13.1.3.

A generalized definition of S-parameters and wave variables can be given by using in Eq. (13.1.4) two different normalization impedances for the input and output ports.

Anticipating that the two-port will be connected to a generator and load impedances \( Z_G \) and \( Z_L \), a particularly convenient choice is to use \( Z_G \) for the input normalization impedance and \( Z_L \) for the output one, leading to the definition of the power waves (as opposed to traveling waves) [982–984,986]:

\[
\begin{align*}
\mathbf{a}'_1 &= \frac{V_1 + Z_G I_1}{\sqrt{R_G}} \\
\mathbf{b}'_1 &= \frac{V_1 - Z_G I_1}{\sqrt{R_G}} \\
\mathbf{a}_2 &= \frac{V_2 - Z_L I_2}{\sqrt{R_L}} \\
\mathbf{b}_2 &= \frac{V_2 + Z_L I_2}{\sqrt{R_L}}
\end{align*}
\]

(13.7.1)

We note that the \( b \)-waves involve the complex-conjugates of the impedances. The quantities \( R_G, R_L \) are the resistive parts of \( Z_G, Z_L \) and are assumed to be positive. These definitions reduce to the conventional traveling ones if \( Z_G = Z_L = Z_0 \).

These "wave" variables can no longer be interpreted as incoming and outgoing waves from the two sides of the two-port. However, as we see below, they have a nice interpretation in terms of power transfer to and from the two-port and simplify the expressions for the power gains. Inverting Eqs. (13.7.1), we have:

\[
\begin{align*}
\mathbf{V}_1 &= \frac{1}{\sqrt{R_G}} \left( Z_G \mathbf{a}_1' + Z_G \mathbf{b}_1' \right) \\
\mathbf{I}_1 &= \frac{1}{\sqrt{R_G}} \left( \mathbf{a}_1' - \mathbf{b}_1' \right) \\
\mathbf{V}_2 &= \frac{1}{\sqrt{R_L}} \left( Z_L \mathbf{a}_2' + Z_L \mathbf{b}_2' \right) \\
\mathbf{I}_2 &= \frac{1}{\sqrt{R_L}} \left( \mathbf{b}_2' - \mathbf{a}_2' \right)
\end{align*}
\]

(13.7.2)

The power waves can be related directly to the traveling waves. For example, expressing Eqs. (13.7.1) and (13.1.5) in matrix form, we have for port-1:

\[
\begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix} = \frac{1}{2 \sqrt{R_G}} \begin{bmatrix}
1 & Z_G \\
1 & -Z_G
\end{bmatrix} \begin{bmatrix}
\mathbf{V}_1 \\
\mathbf{I}_1
\end{bmatrix}, \quad \begin{bmatrix}
\mathbf{V}_1 \\
\mathbf{I}_1
\end{bmatrix} = \frac{1}{\sqrt{Z_0}} \begin{bmatrix}
Z_0 & Z_L \\
1 & -1
\end{bmatrix} \begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix}
\]

It follows that:

\[
\begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix} = \frac{1}{2 \sqrt{R_G}} \begin{bmatrix}
1 & Z_G \\
1 & -Z_G
\end{bmatrix} \begin{bmatrix}
Z_0 & Z_L \\
1 & 1
\end{bmatrix} \begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix} \text{ or,}
\]

\[
\begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix} = \frac{1}{2 \sqrt{R_G}} \begin{bmatrix}
Z_0 & Z_L \\
Z_L & Z_0
\end{bmatrix} \begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix}
\]

(13.7.3)

The entries of this matrix can be expressed directly in terms of the reflection coefficient \( \Gamma_G \). Using the identities of Problem 13.3, we may rewrite Eq. (13.7.3) and its inverse as follows:

\[
\begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix} = \frac{1}{\sqrt{1 - |\Gamma_G|^2}} \begin{bmatrix}
\epsilon^{i\phi_G} & -\Gamma_G \epsilon^{i\phi_G} \\
-\Gamma_G^* \epsilon^{-i\phi_G} & \epsilon^{-i\phi_G}
\end{bmatrix} \begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix}
\]

(13.7.4)

\[
\begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix} = \frac{1}{\sqrt{1 - |\Gamma_G|^2}} \begin{bmatrix}
\epsilon^{-i\phi_G} & \Gamma_G \epsilon^{i\phi_G} \\
\Gamma_G^* \epsilon^{-i\phi_G} & \epsilon^{-i\phi_G}
\end{bmatrix} \begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{b}_1'
\end{bmatrix}
\]

(13.7.5)

Similarly, we have for the power and traveling waves at port-2:

\[
\begin{bmatrix}
\mathbf{a}_2' \\
\mathbf{b}_2'
\end{bmatrix} = \frac{1}{\sqrt{1 - |\Gamma_L|^2}} \begin{bmatrix}
\epsilon^{i\phi_L} & -\Gamma_L \epsilon^{i\phi_L} \\
-\Gamma_L^* \epsilon^{-i\phi_L} & \epsilon^{-i\phi_L}
\end{bmatrix} \begin{bmatrix}
\mathbf{a}_2' \\
\mathbf{b}_2'
\end{bmatrix}
\]

(13.7.6)

\[
\begin{bmatrix}
\mathbf{a}_2' \\
\mathbf{b}_2'
\end{bmatrix} = \frac{1}{\sqrt{1 - |\Gamma_L|^2}} \begin{bmatrix}
\epsilon^{-i\phi_L} & \Gamma_L \epsilon^{i\phi_L} \\
\Gamma_L^* \epsilon^{-i\phi_L} & \epsilon^{-i\phi_L}
\end{bmatrix} \begin{bmatrix}
\mathbf{a}_2' \\
\mathbf{b}_2'
\end{bmatrix}
\]

(13.7.7)

The generalized S-parameters are the scattering parameters with respect to the power wave variables, that is,

\[
\begin{bmatrix}
\mathbf{b}_1' \\
\mathbf{b}_2'
\end{bmatrix} = \begin{bmatrix}
S_{11}' & S_{12}' \\
S_{21}' & S_{22}'
\end{bmatrix} \begin{bmatrix}
\mathbf{a}_1' \\
\mathbf{a}_2'
\end{bmatrix} \Rightarrow \mathbf{b}' = S \mathbf{a}'
\]

(13.7.8)

To relate \( S' \) to the conventional scattering matrix \( S \), we define the following diagonal matrices:
13.7. Generalized S-Parameters and Power Waves

\[
\begin{bmatrix}
F_G & 0 \\
0 & F_L
\end{bmatrix}, \quad \mathbf{F} = \begin{bmatrix}
\frac{e^{j\phi_G}}{\sqrt{1 - |F_G|^2}} & 0 \\
0 & \frac{e^{j\phi_L}}{\sqrt{1 - |F_L|^2}}
\end{bmatrix} = \begin{bmatrix}
F_G & 0 \\
0 & F_L
\end{bmatrix}
\]  \hspace{1cm} (13.7.9)

Using these matrices, it follows from Eqs. (13.7.4) and (13.7.6):

\[
\begin{align*}
a'_{1} &= F_G(a_1 - \Gamma_G b_1) \Rightarrow a' = F(a - \Gamma b) \quad (13.7.10) \\
a'_{2} &= F_L(a_2 - \Gamma_L b_2) \\
b'_{1} &= F_G'(b_1 - \Gamma_G' a_1) \\
b'_{2} &= F_L'(b_2 - \Gamma_L' a_2) \Rightarrow b' = F^*(b - \Gamma^* a)
\end{align*}
\]  \hspace{1cm} (13.7.11)

Using \( b = Sa \), we find

\[
\begin{align*}
a' &= F(a - \Gamma b) = F(I - IS)a \Rightarrow a = (I - IS)^{-1}F^{-1}a' \\
b' &= F^*(S - \Gamma^*)a = F^*(S - \Gamma^*)(I - IS)^{-1}F^{-1}a' = S'a'
\end{align*}
\]

where \( I \) is the 2\times2 unit matrix. Thus, the generalized \( S \)-matrix is:

\[
S' = F^*(S - \Gamma^*)(I - IS)^{-1}F^{-1}
\]  \hspace{1cm} (13.7.12)

We note that \( S' = S \) when \( Z_G = Z_L = Z_0 \), that is, when \( \Gamma_G = \Gamma_L = 0 \). The explicit expressions for the matrix elements of \( S' \) can be derived as follows:

\[
\begin{align*}
S'_{11} &= \frac{(S_{11} - \Gamma_G^*) (1 - S_{22}\Gamma_L) + S_{21}S_{12}\Gamma_L}{(1 - S_{11}\Gamma_G) (1 - S_{22}\Gamma_L) - S_{12}S_{21}\Gamma_G\Gamma_L} e^{-j\Delta} \\
S'_{22} &= \frac{(S_{22} - \Gamma_L^*) (1 - S_{11}\Gamma_G) + S_{12}S_{21}\Gamma_G}{(1 - S_{22}\Gamma_L) (1 - S_{11}\Gamma_G) - S_{21}S_{12}\Gamma_G\Gamma_L} e^{-j\Delta} \\
S'_{21} &= \frac{\sqrt{1 - |F_G|^2} S_{21} \sqrt{1 - |F_L|^2}}{(1 - S_{11}\Gamma_G) (1 - S_{22}\Gamma_L) - S_{12}S_{21}\Gamma_G\Gamma_L} e^{-j(\Delta + \phi_G)} \\
S'_{12} &= \frac{\sqrt{1 - |F_G|^2} S_{12} \sqrt{1 - |F_L|^2}}{(1 - S_{22}\Gamma_L) (1 - S_{11}\Gamma_G) - S_{21}S_{12}\Gamma_G\Gamma_L} e^{-j(\Delta + \phi_G)}
\end{align*}
\]  \hspace{1cm} (13.7.13a)

The \( S'_{11}, S_{22} \) parameters can be rewritten in terms of the input and output reflection coefficients by using Eq. (13.13.2) and the following factorization identities:

\[
\begin{align*}
(S_{11} - \Gamma_G^*) (1 - S_{22}\Gamma_L) + S_{21}S_{12}\Gamma_L &= (\Gamma_G - \Gamma_G^*) (1 - S_{22}\Gamma_L) \\
(S_{22} - \Gamma_L^*) (1 - S_{11}\Gamma_G) + S_{12}S_{21}\Gamma_G &= (\Gamma_G - \Gamma_G^*) (1 - S_{11}\Gamma_G)
\end{align*}
\]

It then follows from Eq. (13.13.13) that:

\[
S'_{11} = \frac{\Gamma_G - \Gamma_G^*}{1 - \Gamma_G^*\Gamma_G} e^{-j\Delta} \quad S'_{22} = \frac{\Gamma_G - \Gamma_G^*}{1 - \Gamma_G^*\Gamma_G} e^{-j\Delta}
\]  \hspace{1cm} (13.7.14)

Therefore, the mismatch factors (13.6.17) are recognized to be:

\[
M_G = 1 - |S'_{11}|^2, \quad M_L = 1 - |S'_{22}|^2
\]  \hspace{1cm} (13.7.15)

The power flow relations (13.2.1) into and out of the two-port are also valid in terms of the power wave variables. Using Eq. (13.7.2), it can be shown that:

\[
P_m = \frac{1}{2} \text{Re}[V_1^*I_1] = \frac{1}{2} |a'|^2 - \frac{1}{2} |b'|^2
\]  \hspace{1cm} (13.7.16)

\[
P_L = \frac{1}{2} \text{Re}[V_2^*I_2] = \frac{1}{2} |b'|^2 - \frac{1}{2} |a'|^2
\]

In the definitions (13.7.1), the impedances \( Z_G, Z_L \) are arbitrary normalization parameters. However, if the two-port is actually connected to a generator \( V_G \) with impedance \( Z_G \) and a load \( Z_L \), then the power waves take particularly simple forms.

It follows from Fig. 13.1.4 that \( V_G = V_1 + Z_GI_1 \) and \( V_2 = Z_LI_2 \). Therefore, definitions Eq. (13.7.1) give:

\[
\begin{align*}
a' &= \frac{V_1 + Z_GI_1}{2\sqrt{R_G}} = \frac{V_G}{2\sqrt{R_G}} \\
a'' &= \frac{V_2 - Z_LI_2}{2\sqrt{R_L}} = 0 \\
b' &= \frac{V_2 + Z_LI_2}{2\sqrt{R_L}} = \frac{2R_L}{2\sqrt{R_L}}I_2 = \sqrt{R_L}I_2
\end{align*}
\]  \hspace{1cm} (13.7.17)

It follows that the available power from the generator and the power delivered to the load are given simply by:

\[
P_{avG} = \frac{|V_G|^2}{8R_G} = \frac{1}{2} |a'|^2
\]  \hspace{1cm} (13.7.18)

\[
P_L = \frac{1}{2} R_L |I_2|^2 = \frac{1}{2} |b'|^2
\]

Because \( a'_1 = 0 \), the generalized scattering matrix gives \( b'_1 = S'_{11}a_1' \) and \( b'_2 = S'_{21}a_1' \). The power expressions (13.7.10) then become:

\[
P_m = \frac{1}{2} |a'|^2 - \frac{1}{2} |b'|^2 = (1 - |S'_{11}|^2) \frac{1}{2} |a'_1|^2 = (1 - |S'_{11}|^2) P_{avG}
\]  \hspace{1cm} (13.7.19)

\[
P_L = \frac{1}{2} |b'|^2 - \frac{1}{2} |a'_1|^2 = \frac{1}{2} |b'_2|^2 = |S'_{21}|^2 \frac{1}{2} |a'_1|^2 = |S'_{21}|^2 P_{avG}
\]

It follows that the transducer and operating power gains are:

\[
G_T = \frac{P_L}{P_{avG}} = |S'_{21}|^2, \quad G_D = \frac{P_L}{P_m} = \frac{|S'_{21}|^2}{1 - |S'_{11}|^2}
\]  \hspace{1cm} (13.7.20)

These also follow from the explicit expressions (13.7.13) and Eqs. (13.6.10) and (13.6.11). We can also express the available power gain in terms of the generalized \( S \)-parameters, that is, \( G_a = |S'_{21}|^2 / (1 - |S'_{22}|^2) \). Thus, we summarize:
13.8 Simultaneous Conjugate Matching

We saw that the transducer, available, and operating power gains become equal to the maximum available gain \( G_{\text{MAG}} \) when both the generator and the load are conjugately matched to the two-port, that is, \( \Gamma_{\text{in}} = \Gamma_{\text{G}}^* \) and \( \Gamma_{\text{L}} = \Gamma_{\text{L}}^* \). Using Eq. (13.5.8), these conditions read explicitly:

\[
\Gamma_{\text{G}}^* = S_{11} + \frac{S_{12}S_{21}G_{\text{L}}}{1 - S_{22}G_{\text{L}}} = S_{11} + \Delta G_{\text{L}}
\]

\[
\Gamma_{\text{L}}^* = S_{22} + \frac{S_{12}S_{21}G_{\text{G}}}{1 - S_{22}G_{\text{G}}} = S_{22} + \Delta G_{\text{G}}
\]

(13.8.1)

Assuming a bilateral two-port, Eqs. (13.8.1) can be solved in the two unknowns \( \Gamma_{\text{G}}, \Gamma_{\text{L}} \) (eliminating one of the unknowns gives a quadratic equation for the other.) The resulting solutions can be expressed in terms of the parameters (13.5.1):

\[
\Gamma_{\text{G}} = \frac{B_1 + \sqrt{B_1^2 - 4|C_1|^2}}{2C_1}
\]

(simultaneous conjugate match) (13.8.2)

\[
\Gamma_{\text{L}} = \frac{B_2 + \sqrt{B_2^2 - 4|C_2|^2}}{2C_2}
\]

where the minus signs are used when \( B_1 > 0 \) and \( B_2 > 0 \), and the plus signs, otherwise.

A necessary and sufficient condition for these solutions to have magnitudes \( |\Gamma_{\text{G}}| < 1 \) and \( |\Gamma_{\text{L}}| < 1 \) is that the Rollett stability factor be greater than unity, \( K > 1 \). This is satisfied when the two-port is unconditionally stable, which implies that \( K > 1 \) and \( B_1 > 0, B_2 > 0 \).

A conjugate match exists also when the two-port is potentially unstable, but with \( K > 1 \). Necessarily, this means that \( B_1 < 0, B_2 < 0 \), and also \( |\Delta| > 1 \). Such cases are rare in practice. For example, most microwave transistors have either \( K > 1 \) and are stable, or, they are potentially unstable with \( K < 1 \) and \( |\Delta| < 1 \).

If the two-port is unilateral, \( S_{12} = 0 \), then the two equations (13.8.1) decouple, so that the optimum conjugately matched terminations are:

\[
\Gamma_{\text{G}} = S_{11}, \quad \Gamma_{\text{L}} = S_{22}^*
\]

(unilateral conjugate match) (13.8.3)

The MATLAB function \texttt{smatch} implements Eqs. (13.8.2). It works only if \( K > 1 \). Its usage is as follows:

\[
[g_{\text{G}}, g_{\text{L}}] = \texttt{smatch}(S);
\]

% conjugate matched terminations \( \Gamma_{\text{G}}, \Gamma_{\text{L}} \)

To realize such optimum conjugately matched terminations, matching networks must be used at the input and output of the two-port as shown in Fig. 13.8.1.

The input matching network can be thought as being effectively connected to the impedance \( Z_{\text{in}} = Z_{\text{G}}^* \) at its output terminals. It must transform \( Z_{\text{in}} \) into the actual impedance of the connected generator, typically, \( Z_0 = 50 \) ohm.

The output matching network must transform the actual load impedance, here \( Z_L \), into the optimum load impedance \( Z_L = Z_{\text{out}}^* \).

Fig. 13.8.1 Input and output matching networks.

The matching networks may be realized in several possible ways, as discussed in Chap. 12. Stub matching, quarter-wavelength matching, or lumped L-section or \Pi\,\text{section networks may be used. In designing the matching networks, it proves convenient to first design the reverse network as mentioned in Sec. 12.13.}

Fig. 13.8.2 shows the procedure for designing the output matching network using a reversed stub matching transformer or a reversed quarter-wave transformer with a parallel stub. In both cases the reversed network is designed to transform the load impedance \( Z_L^* \) into \( Z_0 \).

Fig. 13.8.2 Two types of output matching networks and their reversed networks.

Example 13.8.1: A microwave transistor amplifier uses the Hewlett-Packard AT-41410 NPN bipolar transistor having \( S \)-parameters at 2 GHz [1355]:

\[
[g_{\text{G}}, g_{\text{L}}] = \texttt{smatch}(S);
\]
13.8. Simultaneous Conjugate Matching

\[ S_{11} = 0.61 \angle 163^\circ, \quad S_{21} = 3.72 \angle 59^\circ, \quad S_{12} = 0.05 \angle 42^\circ, \quad S_{22} = 0.45 \angle -48^\circ \]

Determine the optimum conjugately matched source and load terminations, and design appropriate input and output matching networks.

Solution: This is the continuation of Example 13.6.1. The transistor is stable with \( K = 1.1752 \) and \( |\Delta| = 0.1086 \). The function \( \text{smatch} \) gives:

\[ [\Gamma_G, \Gamma_L] = \text{smatch}(S) \Rightarrow \Gamma_G = 0.8179 \angle -162.6697^\circ, \quad \Gamma_L = 0.7495 \angle 52.5658^\circ \]

The corresponding source, load, input, and output impedances are (with appropriate input and output matching networks).

\[ Z_G = Z_{in}^* = 5.1241 - 7.5417j \Omega, \quad Z_L = Z_{out}^* = 33.6758 + 91.4816j \Omega \]

The locations of the optimum reflection coefficients on the Smith chart are shown in Fig. 13.8.3. For comparison, the unilateral solutions of Eq. (13.8.3) are also shown.

**Fig. 13.8.3** Optimum load and source reflection coefficients.

We consider three types of matching networks: (a) microstrip single-stub matching networks with open shunt stubs, shown in Fig. 13.8.4, (b) microstrip quarter-wavelength matching networks with open \( \lambda/8 \) or \( 3\lambda/8 \) stubs, shown in Fig. 13.8.5, and (c) \( L \)-section matching networks, shown in 13.8.6.

In Fig. 13.8.4, the input stub must transform \( Z_{in} \) to \( Z_0 \). It can be designed with the help of the function \( \text{stub1} \), which gives the two solutions:

\[ dl = \text{stub1}(Z_{in}/Z_0, 'po') = \begin{bmatrix} 0.3038 \\ 0.1962 \end{bmatrix}, \quad 0.4271, \quad 0.0247 \]

We choose the lower one, which has the shortest lengths. Thus, the stub length is \( d = 0.1962 \lambda \) and the segment length \( l = 0.0247 \lambda \). Both segments can be realized with microstrips of characteristic impedance \( Z_0 = 50 \) ohm. Similarly, the output matching network can be designed by:

\[ dl = \text{stub1}(Z_{out}/Z_0, 'po') = \begin{bmatrix} 0.3162 \\ 0.1838 \end{bmatrix}, \quad 0.1194, \quad 0.2346 \]

Again, we choose the lower solutions, \( d = 0.1838 \lambda \) and \( l = 0.2346 \lambda \). The solutions using shorted shunt stubs are:

\[ \text{stub1}(Z_{in}/Z_0) = \begin{bmatrix} 0.0538 \\ 0.4462 \end{bmatrix}, \quad 0.4271, \quad 0.0247 \]

\[ \text{stub1}(Z_{out}/Z_0) = \begin{bmatrix} 0.0662 \\ 0.4338 \end{bmatrix}, \quad 0.1194, \quad 0.2346 \]

Using microstrip lines with alumina substrate \( (\epsilon_r = 9.8) \), we obtain the following values for the width-to-height ratio, effective permittivity, and wavelength:

\[ u = \frac{w}{h} = \text{mstrip}(\epsilon_r, Z_0) = 0.9711 \]

\[ \epsilon_{eff} = \text{mstrip}(\epsilon_r, u_{eff}) = 6.5630 \]

\[ \lambda = \frac{\lambda_0}{\sqrt{\epsilon_{eff}}} = 5.8552 \text{ cm} \]

where \( \lambda_0 = 15 \) cm is the free-space wavelength at 2 GHz. It follows that the actual segment lengths are \( d = 1.1486 \text{ cm}, \quad l = 0.1447 \text{ cm} \) for the input network, and \( d = 1.0763 \text{ cm}, \quad l = 1.3734 \text{ cm} \) for the output network.

In the quarter-wavelength method shown in Fig. 13.8.5, we use the function \( \text{qwt2} \) to carry out the design of the required impedances of the microstrip segments. We have for the input and output networks:

\[ [Z_1, Z_2] = \text{qwt2}(Z_{in}, Z_0) = [28.4817, -11.0232] \Omega \]

\[ [Z_1, Z_2] = \text{qwt2}(Z_{out}, Z_0) = [118.7832, 103.8782] \Omega \]

For the input case, we find \( Z_2 = -11.0232 \Omega \), which means that we should use either a \( 3\lambda/8 \)-shorted stub or a \( \lambda/8 \)-opened one. We choose the latter. Similarly, for the output case, we have \( Z_2 = 103.8782 \Omega \), and we choose a \( 3\lambda/8 \)-opened stub. The parameters of each microstrip segment are:

\[ Z_1 = 28.4817 \Omega, \quad u = 2.5832, \quad \epsilon_{eff} = 7.2325, \quad \lambda = 5.578 \text{ cm}, \quad \lambda/4 = 1.394 \text{ cm} \]

\[ Z_2 = 110.0232 \Omega, \quad u = 8.9424, \quad \epsilon_{eff} = 8.2974, \quad \lambda = 5.207 \text{ cm}, \quad \lambda/8 = 0.651 \text{ cm} \]

\[ Z_1 = 118.7832 \Omega, \quad u = 0.0656, \quad \epsilon_{eff} = 5.8790, \quad \lambda = 6.186 \text{ cm}, \quad \lambda/4 = 1.547 \text{ cm} \]

\[ Z_2 = 103.8782 \Omega, \quad u = 0.1169, \quad \epsilon_{eff} = 7.9503, \quad \lambda = 6.149 \text{ cm}, \quad 3\lambda/8 = 2.306 \text{ cm} \]

Finally, the designs using \( L \)-sections shown in Fig. 13.8.6, can be carried out with the help of the function \( \text{match} \). We have the dual solutions for the input and output networks:
13.8 Simultaneous Conjugate Matching

Fig. 13.8.5 Quarter-wavelength matching networks with $\lambda/8$-stubs.

Fig. 13.8.6 Input and output matching with $L$-sections.

\[ [X_1, X_2] = \text{lmatch}(Z_0, Z_{in}, 'n') = \begin{bmatrix} 16.8955 & -22.7058 \\ -16.8955 & 7.6223 \end{bmatrix} \]

\[ [X_1, X_2] = \text{lmatch}(Z_{out}, Z_0, 'n') = \begin{bmatrix} 57.9268 & -107.7472 \\ 502.4796 & 7.6223 \end{bmatrix} \]

According to the usage of $\text{lmatch}$, the output network transforms $Z_0$ into $Z_{out}$, but that is equal to $Z_L$ as required.

Choosing the first rows as the solutions in both cases, the shunt part $X_1$ will be inductive and the series part $X_2$, capacitive. At 2 GHz, we find the element values:

$\begin{align*}
L_1 &= \frac{X_1}{\omega} = 1.3445 \text{ nH}, \quad C_1 = -\frac{1}{\omega X_2} = 3.5047 \text{ pF} \\
L_2 &= \frac{X_2}{\omega} = 4.6097 \text{ nH}, \quad C_2 = -\frac{1}{\omega X_2} = 0.7386 \text{ pF}
\end{align*}$

The output network, but not the input one, also admits a reversed $L$-section solution:

\[ [X_1, X_2] = \text{lmatch}(Z_{out}, Z_0, 'r') = \begin{bmatrix} 71.8148 & 68.0353 \\ -71.8148 & 114.9280 \end{bmatrix} \]

The essential MATLAB code used to generate the above results was as follows:

```matlab
Z0 = 50; f = 2; w = 2*pi*f; la0 = 30/f; er = 9.8; % f in GHz
S = smat([0.61 165 3.72 59 0.05 42 0.45 -48]); % S-matrix
[gG, gl] = smatch(S); % simultaneous conjugate match
plot(gG, '.'); plot(conj(S(1,1)), 'o');
plot(gl, '.'); plot(conj(S(2,2)), 'o'); % single-stub design
ZG = g2z(gG,Z0); Zin = conj(ZG);
ZL = g2z(gl,Z0); Zout = conj(ZL);
d1 = stub1(Zin/Z0, 'po');
d1 = stub1(Zout/Z0, 'po');
u = mstrip(er,Z0); % microstrip w/h ratio
eff = mstripa(er,u); % effective permittivity
la = la0/sqrt(eff); % wavelength within microstrip

[X1, X2] = qwt2(Zin, Z0); % quarter-wavelength with $\lambda/8$ stub
[X1, X2] = qwt2(Zout, Z0);

X12 = lmatch(Z0,Zin,'n'); L1 = X12(1,1)/w; C1 = -1/(w * X12(1,2))*1e3;
X12 = lmatch(Zout,Z0,'n'); L2 = X12(1,1)/w; C2 = -1/(w * X12(1,2))*1e3;
X12 = lmatch(Zout,Z0,'r'); % L, C in units of nH and pF

One could replace the stubs with balanced stubs, as discussed in Sec. 12.9, or use $\Pi$- or $T$-sections instead of $L$-sections. □

13.9 Power Gain Circles

For a stable two-port, the maximum transducer gain is achieved at single pair of points $\Gamma_G, \Gamma_L$. When the gain $G$ is required to be less than $G_{\text{MAG}}$, there will be many possible pairs $\Gamma_G, \Gamma_L$ at which the gain $G$ is realized. The locus of such points $\Gamma_G$ and $\Gamma_L$ on the $\Gamma$-plane is typically a circle of the form:

\[ |\Gamma - c| = r \]  

where $c, r$ are the center and radius of the circle and depend on the desired value of the gain $G$.

In practice, several types of such circles are used, such as unilateral, operating, and available power gain circles, as well as constant noise figure circles, constant SWR circles, and others.

The gain circles allow one to select appropriate values for $\Gamma_G, \Gamma_L$ that, in addition to providing the desired gain, also satisfy other requirements, such as striking a balance between minimizing the noise figure and maximizing the gain.

The MATLAB function $\text{sgcirc}$ calculates the stability circles as well as the operating, available, and unilateral gain circles. Its complete usage is:

```matlab
[c, r] = sgcirc(S,'s'); % source stability circle
[c, r] = sgcirc(S,'l'); % load stability circle
[c, r] = sgcirc(S,'p',G); % operating power gain circle
[c, r] = sgcirc(S,'a',G); % available power gain circle
[c, r] = sgcirc(S,'ui',G); % unilateral input gain circle
[c, r] = sgcirc(S,'uo',G); % unilateral output gain circle

sgcirc(S,'s') % source stability circle
sgcirc(S,'l') % load stability circle
sgcirc(S,'p',G) % operating power gain circle
sgcirc(S,'a',G) % available power gain circle
sgcirc(S,'ui',G) % unilateral input gain circle
sgcirc(S,'uo',G) % unilateral output gain circle
```
where in the last four cases $G$ is the desired gain in dB.

## 13.10 Unilateral Gain Circles

We consider only the unconditionally stable unilateral case, which has $|S_{11}| < 1$ and $|S_{22}| < 1$. The dependence of the transducer power gain on $G_G$ and $G_L$ decouples and the value of the gain may be adjusted by separately choosing $G_G$ and $G_L$. We have from Eq. (13.6.14):

$$G_T = \frac{1 - |G_G|^2}{1 - |S_{22}|^2} |S_{21}|^2 \frac{1 - |G_L|^2}{1 - |S_{22}|^2}^2 = G_G |S_{21}|^2 G_L$$  \hspace{1cm} (13.10.1)

The input and output gain factors $G_G, G_L$ satisfy the inequalities (13.6.24). Concentrating on the output gain factor, the corresponding gain circle is obtained as the locus of points $G_L$ that will lead to a fixed value, say $G_L = G$, which necessarily must be less than the maximum $G_2$ given in Eq. (13.6.23), that is,

$$1 - |G_L|^2 \leq G \leq G_2 = 1 - |S_{22}|^2$$  \hspace{1cm} (13.10.2)

Normalizing the gain $G$ to its maximum value $g = G/G_2 = G(1 - |S_{22}|^2)$, we may rewrite (13.10.2) in the form:

$$\frac{(1 - |G_L|^2)(1 - |S_{22}|^2)}{1 - |S_{22}|^2} = g \leq 1$$  \hspace{1cm} (13.10.3)

This equation can easily be rearranged into the equation of a circle $|G_L - c| = r$, with center and radius given by:

$$c = \frac{gS_{22}^*}{1 - (1 - g)|S_{22}|^2}, \quad r = \frac{\sqrt{1 - g(1 - |S_{22}|^2)}}{1 - (1 - g)|S_{22}|^2}$$  \hspace{1cm} (13.10.4)

When $g = 1$ or $G = G_2$, the gain circle collapses onto a single point, that is, the optimum point $G_1 = S_{22}^*$. Similarly, we find for the constant gain circles of the input gain factor:

$$c = \frac{gS_{11}^*}{1 - (1 - g)|S_{11}|^2}, \quad r = \frac{\sqrt{1 - g(1 - |S_{11}|^2)}}{1 - (1 - g)|S_{11}|^2}$$  \hspace{1cm} (13.10.5)

where here, $g = G/G_1 = G(1 - |S_{11}|^2)$ and the circles are $|G_L - c| = r$.

Both sets of $c, r$ satisfy the conditions $|c| < 1$ and $|c| + r < 1$, the latter implying that the circles lie entirely within the unit circle $|G| < 1$, that is, within the Smith chart.

### Example 13.10.1:

A unilateral microwave transistor has $S$-parameters:

$$S_{11} = 0.8 \angle 120^\circ, \quad S_{21} = 4 \angle 60^\circ, \quad S_{12} = 0, \quad S_{22} = 0.2 \angle -30^\circ$$

The unilateral MAG and the maximum input and output gains are obtained as follows:

$$G_{MAG,\text{un}} = \text{sgain}(S, 'u') = 16.66 \text{ dB}$$

$$G_1 = \text{sgain}(S, 'ui^\dagger') = 4.44 \text{ dB}$$

$$G_2 = \text{sgain}(S, 'uo^\dagger') = 0.18 \text{ dB}$$

Most of the gain is accounted for by the factor $|S_{22}|^2$, which is 12.04 dB. The constant input gain circles for $G_G = 1, 2, 3 \text{ dB}$ are shown in Fig. 13.10.1. Their centers lie along the ray to $S_{11}$. For example, the center and radius of the 3-dB case were computed by:

$$[c_3, r_3] = \text{sgcerc}(S, 'ui^\dagger', 3) \Rightarrow c_3 = 0.701 \angle -120^\circ, \quad r_3 = 0.233$$

![Unilateral input gain circles](image-url)

**Fig. 13.10.1** Unilateral input gain circles.

Because the output does not provide much gain, we may choose the optimum value $G_L = S_{22}^* = 0.2 \angle 30^\circ$. Then, with any point $G_G$ along the 3-dB input gain circle the total transducer gain will be in dB:

$$G_T = G_G + |S_{22}|^2 + G_L = 3 + 12.04 + 0.18 = 15.22 \text{ dB}$$

Points along the 3-dB circle are parametrized as $G_G = c_3 + r_3 e^{i\phi}$, where $\phi$ is any angle. Choosing $\phi = \arg(S_{11}^*) - \pi$ will correspond to the point on the circle that lies closest to the origin, that is, $G_G = 0.468 \angle -120^\circ$, as shown in Fig. 13.10.1. The corresponding generator and load impedances will be:

$$Z_G = 69.21 + 14.42 j \Omega, \quad Z_L = 23.15 - 24.02 j \Omega$$

The MATLAB code used to generate these circles was:

```matlab
S = smat([0.8, 120, 4, 60, 0, 0, 0.2, -30]);
[cG1, rG1] = sgcerc(S, 'ui^\dagger', 1);
[cG2, rG2] = sgcerc(S, 'ui^\dagger', 2);
[cG3, rG3] = sgcerc(S, 'ui^\dagger', 3);
smith; smithcir(cG1, rG1); smithcir(cG2, rG2); smithcir(cG3, rG3);
c = exp(-j*angle(S(1,1))) * line([0, real(c)], [0, imag(c)]);
gG = c3 - r3*exp(j*angle(c3));
plot(conj(S(1,1)), '.'); plot(conj(S(2,2)), '.'); plot(gG, '.');
```

G

G

1 dB

2 dB

3 dB

The MATLAB code used to generate these circles was:
The input and output matching networks can be designed using open shunt stubs as in Fig. 13.8.4. The stub lengths are found to be (with \( Z_0 = 50 \Omega \)):

\[
dl = \text{stub1}(Z_L^*/Z_0, 'po') = \begin{bmatrix}
0.3704 & 0.3304 \\
0.1296 & 0.0029 \\
0.4383 & 0.0994 \\
0.0617 & 0.3173
\end{bmatrix}
\]

Choosing the shortest lengths, we have for the input network \( d = 0.1296 \lambda, l = 0.0029 \lambda \), and for the output network, \( d = 0.0617 \lambda, l = 0.3173 \lambda \). Fig. 13.10.2 depicts the complete matching circuit.

![Fig. 13.10.2 Input and output stub matching networks.](image-url)

### 13.11 Operating and Available Power Gain Circles

Because the transducer power gain \( G_T \) depends on two independent parameters—the source and load reflection coefficients—it is difficult to find the simultaneous locus of points for \( \Gamma_L, \Gamma_L \) that will result in a given value for the gain.

If the generator is matched, \( \Gamma_m = \Gamma_m^* \), then the transducer gain becomes equal to the operating gain \( G_T = G_p \) and depends only on the load reflection coefficient \( \Gamma_L \). The locus of points \( \Gamma_L \) that result in fixed values of \( G_p \) are the operating power gain circles. Similarly, the available power gain circles are obtained by matching the load end, \( \Gamma_L = \Gamma_L^{\text{sat}} \), and varying \( \Gamma_G \) to achieve fixed values of the available power gain.

Using Eqs. (13.6.11) and (13.5.8), the conditions for achieving a constant value, say \( G \), for the operating or the available power gains are:

\[
G_p = \frac{1 - |\Gamma_L|^2}{1 - S_{22} |\Gamma_L|^2} = G, \quad G_p^* = G_m = \frac{S_{11} - \Delta \Gamma_L}{1 - S_{22} \Gamma_L}
\]

\[
G_a = \frac{1 - |\Gamma_L|^2}{1 - S_{11} |\Gamma_L|^2} = G, \quad G_a^* = G_o = \frac{S_{22} - \Delta \Gamma_G}{1 - S_{11} \Gamma_G}
\]

We consider the operating gain first. Defining the normalized gain \( g = G / |S_{21}|^2 \), substituting \( G_m \), and using the definitions (13.5.1), we obtain the condition:

\[
g = \frac{1 - |\Gamma_L|^2}{1 - S_{22} |\Gamma_L|^2} = \frac{1 - |\Gamma_L|^2}{1 - S_{11} - \Delta |\Gamma_L|^2}
\]

\[
= \frac{|S_{22}^2 - |\Delta|^2|\Gamma_L|^2 - (S_{22} - \Delta S_{11}) \Gamma_L - (S_{22} - \Delta^* S_{11}) \Gamma_L^* + 1 - |\Gamma_L|^2}{D_2 |\Gamma_L|^2 - C_2 \Gamma_L - C_2^* \Gamma_L^* + 1 - |\Gamma_L|^2}
\]

This can be rearranged into the form:

\[
|\Gamma_L|^2 - \frac{g C_2}{1 + g D_2} \Gamma_L - \frac{g C_2^*}{1 + g D_2} \Gamma_L^* = \frac{1 - g (1 - |\Gamma_L|^2)}{1 + g D_2}
\]

and then into the circle form:

\[
|\Gamma_L|^2 - \frac{g C_2}{1 + g D_2} \Gamma_L = \frac{1 - g (1 - |\Gamma_L|^2)}{1 + g D_2}
\]

Using the identities (13.5.2) and \( 1 - |\Gamma_L|^2 = 2K|S_{12} S_{21}| + D_2 \), which follows from (13.5.1), the right-hand side of the above circle form can be written as:

\[
g^2 |S_{21}|^2 + \frac{1 - g (1 - |\Gamma_L|^2)}{1 + g D_2} = \frac{g^2 |S_{12} S_{21}|^2 - 2 g K |S_{12} S_{21}| + 1}{(1 + g D_2)^2}
\]

Thus, the operating power gain circle will be \(|\Gamma_L - c|^2 = r^2\) with center and radius:

\[
c = \frac{g C_2}{1 + g D_2}, \quad r = \frac{\sqrt{g^2 |S_{12} S_{21}|^2 - 2 g K |S_{12} S_{21}| + 1}}{1 + g D_2}
\]

The points \( \Gamma_L \) on this circle result into the value \( G_p = G \) for the operating gain. Such points can be parametrized as \( \Gamma_L = c + r e^{i \phi} \), where \( 0 \leq \phi \leq 2 \pi \). As \( \Gamma_L \) traces this circle, the conjugately matched source coefficient \( \Gamma_G = \Gamma_m^* \) will also trace a circle because \( \Gamma_m \) is related to \( \Gamma_L \) by the bilinear transformation (13.5.8).

In a similar fashion, we find the available power gain circles to be \(|\Gamma_G - c|^2 = r^2\), where \( G = G / |S_{21}|^2 \) and:

\[
c = \frac{g C_2}{1 + g D_1}, \quad r = \frac{\sqrt{g^2 |S_{12} S_{21}|^2 - 2 g K |S_{12} S_{21}| + 1}}{1 + g D_1}
\]

We recall from Sec. 13.5 that the centers of the load and source stability circles were \( c_L = C_2^* / D_2 \) and \( c_G = C_2^* / D_1 \). It follows that the centers of the operating power gain circles are along the same ray as \( c_L \), and the centers of the available gain circles are along the same ray as \( c_G \).

For an unconditionally stable two-port, the gain \( G \) must be \( 0 \leq G \leq G_{\text{MAG}} \), with \( G_{\text{MAG}} \) given by Eq. (13.6.20). It can be shown easily that the quantities under the square
13.11. Operating and Available Power Gain Circles

The gain circles lie entirely within the unit circle, for example, we have \( r_3 + |c_3| = 0.9221 < 1 \), and their centers lie along the ray of \( c_L \). As \( \Gamma_L \) traces the 15-dB circle, the corresponding \( \Gamma_G = \Gamma_{in}^L \) traces its own circle, also lying within the unit circle. The following MATLAB code computes and adds that circle to the above Smith chart plots:

In particular, the point \( \Gamma_L \) on the 15-dB circle that lies closest to the origin is \( \Gamma_{in} = c_3 - r_3 e^{j \angle c_3} = 0.3285 e^{j25.56^\circ} \). The corresponding matched load will be \( \Gamma_G = \Gamma_{in}^L = 0.6805 e^{-j163.88^\circ} \). These and the corresponding source and load impedances were computed by the MATLAB statements:

\[
\begin{align*}
    &GL = c_3 - r_3 e^{j \angle c_3}; \\
    &zL = g2z(GL); \\
    &zG = g2z(GG);
\end{align*}
\]

The source and load impedances normalized to \( Z_0 = 50 \) ohm are:

\[
\begin{align*}
    &Z_L = \frac{zL}{Z_0} = 0.1938e^{-j0.1363}, \quad Z_L = \frac{zL}{Z_0} = 1.2590 + 0.7361j
\end{align*}
\]

The matching circuits can be designed in a variety of ways as in Example 13.8.1. Using open shunt stubs, we can determine the stub and line segment lengths with the help of the function \texttt{stub1}:

\[
\begin{align*}
    &dL = stub1(z^*_G, \Gamma_{in}^\ast; \Gamma^\ast) = \begin{bmatrix} 0.3286 & 0.4122 \\ 0.1714 & 0.0431 \end{bmatrix} \\
    &dL = stub1(z^*_L, \Gamma_{in}^\ast; \Gamma^\ast) = \begin{bmatrix} 0.4033 & 0.0786 \\ 0.0967 & 0.2754 \end{bmatrix}
\end{align*}
\]

In both cases, we may choose the lower solutions as they have shorter total length \( d + l \).

The available power gain circles can be determined in a similar fashion with the help of the MATLAB statements:

\[
\begin{align*}
    &[c1,r1] = sgccir(c1,'a',13); \quad \% c_1 = 0.5384 e^{j162.67^\circ}, r_1 = 0.4373 \\
    &[c2,r2] = sgccir(c2,'a',14); \quad \% c_2 = 0.6227 e^{j162.67^\circ}, r_2 = 0.3422 \\
    &[c3,r3] = sgccir(c3,'a',15); \quad \% c_3 = 0.7111 e^{j162.67^\circ}, r_3 = 0.2337 \\
    &[cG,rG] = sgccir(cG,'s',1); \quad \% c_G = 1.5748 e^{j162.67^\circ}, r_G = 0.5162
\end{align*}
\]

The following MATLAB code computes and adds that circle to the above Smith chart plots:

\[
\begin{align*}
    &phi = linspace(0,2\ast pi,361); \quad \% equally spaced angles at 1\textsuperscript{st} \textsuperscript{md} \\
    &gG = conj(gin(S,gG)); \quad \% points on 15-dB available gain circle \\
    &plot(gG); \quad \% circle of conjugate matched source points \\
    &gL = conj(gin(S,gL)); \quad \% equally spaced angles at 1\textsuperscript{st} \textsuperscript{md} \\
    &zL = g2z(gL); \quad \% points on 15-dB operating gain circle \\
    &plot(gL); \quad \% circle of conjugate matched source points
\end{align*}
\]

\[
\begin{align*}
    &G_{in} = 13 \text{ dB} \\
    &G_{in} = 14 \text{ dB} \\
    &G_{in} = 15 \text{ dB}
\end{align*}
\]

\[
\begin{align*}
    &cG, rG \quad \% plot entire source stability circle \\
    &[c1,r1] \quad \% plot entire source stability circle \\
    &[c2,r2] \quad \% plot entire source stability circle \\
    &[c3,r3] \quad \% plot entire source stability circle
\end{align*}
\]

Again, the circles lie entirely within the unit circle. As \( \Gamma_G \) traces the 15-dB circle, the corresponding matched load \( \Gamma_L = \Gamma_{in}^L \) traces its own circle on the \( \Gamma \)-plane. It can be plotted with:

\[
\begin{align*}
    &phi = linspace(0,2\ast pi,361); \quad \% equally spaced angles at 1\textsuperscript{st} \textsuperscript{md} \\
    &gG = conj(gin(S,gG)); \quad \% points on 15-dB available gain circle \\
    &plot(gG); \quad \% circle of conjugate matched source points \\
\end{align*}
\]
In particular, the point \( \Gamma_G = c_1 - r_2 e^{i\arg(c_1)} = 0.4774 \angle -162.67^\circ \) lies closest to the origin.

The corresponding matched load will have \( \Gamma_L = \Gamma_{\text{out}} = 0.5728 \angle 50.76^\circ \). The resulting normalized impedances are:

\[
z_G = \frac{Z_G}{z_0} = 0.3609 - 0.1329j, \quad z_L = \frac{Z_L}{z_0} = 1.1135 + 1.4704j
\]

and the corresponding stub matching networks will have lengths:

\[
\text{stub1}(z_G^\ast, 'po') = \begin{bmatrix} 0.3684 & 0.3905 \\ 0.1316 & 0.0613 \end{bmatrix}, \quad \text{stub1}(z_L^\ast, 'po') = \begin{bmatrix} 0.3488 & 0.1030 \\ 0.1512 & 0.2560 \end{bmatrix}
\]

The lower solutions have the shortest lengths. For both the operating and available gain cases, the stub matching circuits will be similar to those in Fig. 13.8.4.

When the two-port is potentially unstable (but with \( |S_{11}| < 1 \) and \( |S_{22}| < 1 \)), the stability circles intersect with the unit-circle, as shown in Fig. 13.5.2. In this case, the operating and available power gain circles also intersect the unit-circle and at the same points as the stability circles.

We demonstrate this in the specific case of \( K < 1, |S_{11}| < 1, |S_{22}| < 1 \), but with \( D_2 > 0 \), an example of which is shown in Fig. 13.11.2. The intersection of an operating gain circle with the unit-circle is obtained by setting \( |\Gamma_L| = 1 \) in the circle equation \( |\Gamma_L - c| = r \). Writing \( \Gamma_L = e^{i\theta} \) and \( c = |c|e^{i\theta_c} \), we have:

\[
r^2 = |\Gamma_L - c|^2 = 1 - 2|c|\cos(\theta - \theta_c) + |c|^2 \quad \Rightarrow \quad \cos(\theta - \theta_c) = \frac{1 + |c|^2 - r^2}{2|c|}
\]

Similarly, the intersection of the load stability circle with the unit-circle leads to the relationship:

\[
r^2 = |\Gamma_L - c_L|^2 = 1 - 2|c_L|\cos(\theta - \theta_c) + |c_L|^2 \quad \Rightarrow \quad \cos(\theta - \theta_c) = \frac{1 + |c_L|^2 - r^2}{2|c_L|}
\]

Because \( c = gC_2^\ast/(1 + gD_2) \), \( c_L = C_2^\ast/D_2 \), and \( D_2 > 0 \), it follows that the phase angles of \( c \) and \( c_L \) will be equal, \( \theta = \theta_c \). Therefore, in order for the load stability circle and the gain circle to intersect the unit-circle at the same \( \Gamma_L = e^{i\theta} \), the following condition must be satisfied:

\[
\cos(\theta - \theta_c) = \frac{1 + |c|^2 - r^2}{2|c|} = \frac{1 + |c_L|^2 - r^2}{2|c_L|} \quad (13.11.5)
\]

Using the identities \( 1 - |S_{11}|^2 = B_2 - D_2 \) and \( 1 - |S_{11}|^2 = (|c_L|^2 - r^2)D_2 \), which follow from Eqs. (13.5.1) and (13.5.6), we obtain:

\[
\frac{1 + |c_L|^2 - r^2}{2|c_L|} = \frac{1 + (B_2 - D_2)/D_2}{2|C_2|/|D_2|} = \frac{B_2}{2|C_2|}
\]

where we used \( D_2 > 0 \). Similarly, Eq. (13.11.2) can be written in the form:

\[
r^2 = |c|^2 + \frac{1 - g}{1 + gD_2} \quad \Rightarrow \quad |c|^2 - r^2 = \frac{g(1 - |S_{11}|^2) - 1}{1 + gD_2} = \frac{g(B_2 - D_2) - 1}{1 + gD_2}
\]

Therefore, we have:

\[
\frac{1 + |c|^2 - r^2}{2|c|} = \frac{1 + (g(B_2 - D_2) - 1)/(1 + gD_2)}{2g|C_2|/(1 + gD_2)} = \frac{B_2}{2|C_2|}
\]

Thus, Eq. (13.11.5) is satisfied. This condition has two solutions for \( \theta_L \) that correspond to the two points of intersection with the unit-circle. When \( D_2 > 0 \), we have \( \arg c = \arg C_2^\ast = -\arg C_2 \). Therefore, the two solutions for \( \Gamma_L = e^{i\theta} \) will be:

\[
\Gamma_L = e^{i\theta_1}, \quad \theta_L = -\arg(C_2) \pm \cos \left( \frac{B_1}{2|C_1|} \right) \quad (13.11.6)
\]

Similarly, the points of intersection of the unit-circle and the available gain circles and source stability circle are:

\[
\Gamma_G = e^{i\theta}, \quad \theta_G = -\arg(C_1) \pm \cos \left( \frac{B_1}{2|C_1|} \right) \quad (13.11.7)
\]

Actually, these expressions work also when \( D_2 < 0 \) or \( D_1 < 0 \).

**Example 13.11.2:** The microwave transistor Hewlett-Packard AT-41410 NPN is potentially unstable at 1 GHz with the following S-parameters [1355]:

\[
S_{11} = 0.6 \angle -163^\circ, \quad S_{21} = 7.12 \angle 86^\circ, \quad S_{12} = 0.039 \angle 35^\circ, \quad S_{22} = 0.50 \angle -38^\circ
\]

Calculate \( G_{\text{MSG}} \) and plot the operating and available power gain circles for \( G = 20, 21, 22 \) dB. Then, design source and load matching circuits for the 22-dB case by choosing the reflection coefficients that have the smallest magnitudes.

**Solution:** The MSG computed from Eq. (13.6.21) is \( G_{\text{MSG}} = 22.61 \) dB. Fig. 13.11.2 depicts the operating and available power gain circles as well as the load and source stability circles. The stability parameters are: \( K = 0.7667, \mu = 0.8643, |\Delta| = 0.1893, D_1 = 0.3242, D_2 = 0.2142 \). The computations and plots are done with the following MATLAB code:

```matlab
S = smat([0.60, -163, 7.12, 86, 0.039, 35, 0.50, -38]); % S-parameters
[K,mu,D1,D2,C1,D2] = param(S); % stability parameters
Gmsg = db(sgain(S,'msg')) ; % Gmsg = 22.61 dB
% operating power gain circles:
[c1,r1] = sgccirc(S,'p',20); % c1 = 0.6418\angle50.80^\circ, r1 = 0.4768
[c2,r2] = sgccirc(S,'p',21); % c2 = 0.7502\angle50.80^\circ, r2 = 0.4221
[c3,r3] = sgccirc(S,'p',22); % c3 = 0.8666\angle50.80^\circ, r3 = 0.3893
% load and source stability circles:
[cL,rL] = sgccirc(S,'l'); % cL = 2.1608\angle50.80^\circ, rL = 1.2965
[cG,rG] = sgccirc(S,'g'); % cG = 1.7456\angle71.69^\circ, rG = 0.8566
smith; smithcir(cL,rL,1.5); smithcir(cG,rG,1.5); % plot Smith charts
smithcir(cL,r1); smithcir(c2,r2); smithcir(c3,r3); % plot gain circles
gL = c3 - r3*exp(i*angle(c3)); % gL of smallest magnitude
gG = conj(gpin(S,gL)); % gG of smallest magnitude
plot(gL,'o'); plot(gG,'o'); % corresponding matched \( G_L \)
```

The function `db` converts absolute scales to dB. The function `ab` converts from dB to absolute units.
13.12 Noise Figure Circles

The internally generated noise is quantified in practice either by the effective noise temperature \( T_e \), or by the noise figure \( F \) of the device. The internal noise power is given by \( P_n = kT_eB \), where \( k \) is the Boltzmann constant and \( B \) the bandwidth in Hz. These concepts are discussed further in Sec. 15.8. The relationship between \( T_e \) and \( F \) is defined in terms of a standard reference temperature \( T_0 = 290 \text{ K (degrees Kelvin)} \)

\[
F = 1 + \frac{T_e}{T_0}
\]  

(13.12.1)

The noise figure is usually quoted in dB, \( F_{dB} = 10 \log_{10} F \). Because the available gain of a two-port depends on the source impedance \( Z_G \), or the source reflection coefficient \( \Gamma_G \), so will the noise figure.

The optimum source impedance \( Z_{Gopt} \) corresponds to the minimum noise figure \( F_{min} \) that can be achieved by the two-port. For other values of \( Z_G \), the noise figure \( F \) is greater than \( F_{min} \) and is given by [117–120]:

\[
F = F_{min} + \frac{r_n}{R_G|Z_{Gopt}|^2} |Z_G - Z_{Gopt}|^2
\]  

(13.12.2)

where \( R_G = \text{Re}(Z_G) \) and \( r_n \) is an equivalent noise resistance. We note that \( F = F_{min} \) when \( Z_G = Z_{Gopt} \). Defining the normalized noise resistance \( r_n = R_n/\rho_0 \), where \( \rho_0 = 50 \text{ ohm} \), we may write Eq. (13.12.2) in terms of the corresponding source reflection coefficients:

\[
F = F_{min} + 4r_n \frac{|\Gamma_G - \Gamma_{Gopt}|^2}{1 + |\Gamma_{Gopt}|^2(1 - |\Gamma_G|^2)}
\]  

(13.12.3)

The parameters \( F_{min}, r_n \), and \( \Gamma_{Gopt} \) characterize the noise properties of the two-port and are usually known.

In designing low-noise microwave amplifiers, one would want to achieve the minimum noise figure and the maximum gain. Unfortunately, the optimum source reflection coefficient \( \Gamma_{Gopt} \) does not necessarily correspond to the maximum available gain.

The noise figure circles and the available gain circles are useful tools that allow one to obtain a balance between low noise and high gain designs. The noise figure circles are the locus of points \( \Gamma_G \) that correspond to fixed values of \( F \). They are obtained by rewriting Eq. (13.12.3) as the equation of a circle \( |\Gamma_G - c|^2 = r^2 \). We write Eq. (13.12.3) in the form:

\[
\frac{|\Gamma_G - \Gamma_{Gopt}|^2}{1 - |\Gamma_G|^2} = N, \quad \text{where} \quad N = \frac{(F - F_{min})|1 + |\Gamma_{Gopt}|^2}{4r_n}
\]  

(13.12.4)

which can be rearranged into the circle equation:

\[
|\Gamma_G - \frac{\Gamma_{Gopt}}{N+1}|^2 = \frac{N^2 + N(1 - |\Gamma_{Gopt}|^2)}{(N+1)^2}
\]

Thus, the center and radius of the noise figure circle are:

\[
c = \frac{\Gamma_{Gopt}}{N+1}, \quad r = \sqrt{\frac{N^2 + N(1 - |\Gamma_{Gopt}|^2)}{N+1}}
\]  

(13.12.5)

13. S-Parameters

\[
\text{figure; smith; smithcir(c1m,r1,1.5); smithcir(cGm,rG,1.5);}  
\text{smithcir(c1,m,r2); smithcir(c2,m,r3); smithcir(c3,m,r3);}  
\text{gG = c3 - r3*exp(j*angle(c3)); \quad \% \Gamma_G of smallest magnitude}  
\text{gl = conj(gout(S,gG)); \quad \% \text{corresponding matched } \Gamma_L}  
\text{plot(gG,,'.'); plot(gL,',');}  
\text{
\begin{align*}
\text{Because } D_1 > 0 \text{ and } D_2 > 0, \text{ the stability regions are the portions of the unit-circle that lie outside the source and load stability circles. We note that the operating gain circles intersect the unit-circle at exactly the same points as the source stability circles.} \\
\text{The value of } \Gamma_L \text{ on the 22-dB operating gain circle that lies closest to the origin is } \Gamma_L = c_3 - r_3 e^{j \text{angle}(c_3)} = 0.4773 \angle 50.80^\circ \text{ and the corresponding matched source is } \Gamma_G = \Gamma_L = 0.7632 \angle 167.69^\circ. \text{ We note that both } \Gamma_L \text{ and } \Gamma_G \text{ lie in their respective stability regions.} \\
\text{For the 22-dB available gain circle (also denoted by } c_3, r_3), \text{ the closest } \Gamma_G \text{ to the origin will be } \Gamma_G = c_3 - r_3 e^{j \text{angle}(c_3)} = 0.5559 \angle 171.69^\circ \text{ with a corresponding matched load } \Gamma_L = \Gamma_{out} = 0.7147 \angle 45.81^\circ. \text{ Again, both } \Gamma_L, \Gamma_G \text{ lie in their stable regions.} \\
\text{Once the } \Gamma_G, \Gamma_L \text{ have been determined, the corresponding matching input and output networks can be designed with the methods of Example 13.8.1.} 
\end{align*}
\]
The MATLAB function `nfcirc` implements Eq. (13.12.5). Its inputs are the noise parameters $F_{\text{min}}$, $r_n$, $\Gamma_{\text{Gopt}}$, and the desired value of $F$ in dB, and its outputs are $c$, $r$:

$$[c, r] = \text{nfcirc}(F, F_{\text{min}}, r_n, \Gamma_{\text{Gopt}}); \quad \text{\% noise figure circles}$$

The function `nfig` implements Eq. (13.12.3). Its inputs are $F_{\text{min}}$, $r_n$, $\Gamma_{\text{Gopt}}$, and a vector of values of $\Gamma_G$, and its output is the corresponding vector of values of $F$:

$$F = \text{nfig}(F_{\text{min}}, r_n, \Gamma_{\text{Gopt}}, \Gamma_G); \quad \text{\% calculate noise figure } F \text{ in dB}$$

**Example 13.12.1:** The microwave transistor of Example 13.11.1 has the following noise parameters at 2 GHz [1355]: $F_{\text{min}} = 1.6$ dB, $r_n = 0.16$, and $\Gamma_{\text{Gopt}} = 0.26\angle172^\circ$.

Determine the matched load $\Gamma_{\text{Lopt}}$ corresponding to $\Gamma_{\text{Gopt}}$ and calculate the available gain. Then, plot the noise figure circles for $F = 1.7, 1.8, 1.9, 2.0$ dB.

For the 1.8-dB noise figure circle, determine $\Gamma_G$, $\Gamma_L$ that correspond to the maximum possible available gain and design appropriate input and output matching networks.

**Solution:** The conjugate matched load corresponding to $\Gamma_{\text{Gopt}}$ is:

$$\Gamma_{\text{Lopt}} = \Gamma_{\text{Gopt}}^* = \frac{\overline{S_{22}} - \Delta \Gamma_{\text{Gopt}}}{1 - \overline{S_{11}} \Gamma_{\text{Gopt}}} = 0.4927\angle52.50^\circ$$

The value of the available gain at $\Gamma_{\text{Gopt}}$ is $G_{\text{Aopt}} = 13.66$ dB. This is to be compared with the MAG of 16.18 dB determined in Example 13.11.1. To increase the available gain, we must also increase the noise figure. Fig. 13.12.1 shows the locations of the optimum reflection coefficients, as well as several noise figure circles.

The MATLAB code for generating this graph was:

```matlab
S = smat([0.61, 165, 3.72, 59, 0.05, 42, 0.45, -48]);
Fmin = 1.6; rn = 0.16; gGopt = p2c(0.26, 172);
Gmag = db(sgain(S,'mag'));
Gaopt = db(sgain(S,gGopt,'a'));
gLopt = conj(gout(S,gGopt));
G = nfig(Fmin, rn, gGopt, gG);
smith; plot([gGopt, gLopt],'.');
[c1,r1] = nfcirc(1.7,Fmin,rn,gGopt);
[c2,r2] = nfcirc(1.8,Fmin,rn,gGopt);
[c3,r3] = nfcirc(1.9,Fmin,rn,gGopt);
[c4,r4] = nfcirc(2.0,Fmin,rn,gGopt);
smith; plot([gGopt, gLopt],'.');
smithcir(c1,r1); smithcir(c2,r2); smithcir(c3,r3); smithcir(c4,r4);
```

Thus, we see that increasing the gain comes at the price of increasing the noise figure. As $\Gamma_G$ traces the $F = 1.8$ dB circle, the available gain $G_a$ varies as shown in Fig. 13.12.2. Points around this circle can be parametrized as $\Gamma_G = c_2 + r_2 e^{j\phi}$, with $0 \leq \phi \leq 2\pi$. Fig. 13.12.2 plots $G_a$ versus the angle $\phi$. We note that the gain varies between the limits $12.22 \leq G_a \leq 14.81$ dB.

The larger the noise figure $F$, the larger the radius of its circle. As $F$ increases, so does the available gain. But as the gain increases, the radius of its circle decreases. Thus, for a fixed value of $F$, there will be a maximum value of the available gain corresponding to that gain circle that has the smallest radius and is tangent to the noise figure circle.

In the extreme case of the maximum available gain, the available gain circle collapses to a point—the simultaneous conjugate matched point $\Gamma_{\text{Gopt}} = 0.8179\angle-162.67^\circ$—with a corresponding noise figure of $F = 4.28$ dB. These results can be calculated by the MATLAB statements:

```matlab
G = smatch(S);
F = nfig(Fmin, rn, gopt, gG);
```

The maximum value, $G_a = 14.81$ dB, is reached when $\Gamma_G = 0.4478\angle-169.73^\circ$, with a resulting matched load $\Gamma_L = \Gamma_{\text{Gopt}} = 0.5574\angle52.50^\circ$. The two points $\Gamma_G$, $\Gamma_L$, as well as the

---

Footnote 1: The function `p2c` converts from phasor form to cartesian complex form, and the function `c2p`, from cartesian to phasor form.
13.12. Noise Figure Circles

The lower solutions have shorter total lengths $d + l$. The implementation of the matching networks with microstrip lines will be similar to that in Fig. 13.8.4.

If the two-port is potentially unstable, one must be check that the resulting solutions for $\Gamma_G, \Gamma_L$ both lie in their respective stability regions. Problems 13.6 and 13.7 illustrate the design of such potentially unstable low noise microwave amplifiers.

13.13 Problems

13.1 Using the relationships (13.4.3) and (13.4.6), derive the following identities:

$$(Z_{11} + Z_G)(Z_{22} + Z_L) - Z_{11}Z_{22} =$$

$$(Z_{22} + Z_L)(Z_{11} + Z_G) = (Z_{11} + Z_G)(Z_{out} + Z_L)$$

$$(1 - S_{11}\Gamma_G)(1 - S_{22}\Gamma_L) - S_{12}S_{21}\Gamma_G\Gamma_L =$$

$$(1 - S_{22}\Gamma_L)(1 - \Gamma_L\Gamma_G) = (1 - S_{11}\Gamma_G)(1 - \Gamma_L\Gamma_G)$$

Using Eqs. (13.4.4) and (13.4.5), show that:

$$\frac{Z_{21}}{Z_{22} + Z_L} = \frac{S_{21}}{1 - S_{22}\Gamma_L} = \frac{1 - \Gamma_L}{1 - \Gamma_L\Gamma_G}$$

Finally, for the real part $R_L = \text{Re}(Z_L)$, show that:

$$Z_L = Z_0 \frac{1 + \Gamma_L}{1 - \Gamma_L} \Rightarrow R_L = Z_0 \frac{|1 - \Gamma_L|^2}{|1 - \Gamma_L|^2}$$

13.2 Computer Experiment. The Hewlett-Packard ATF-10136 GaAs FET transistor has the following $S$-parameters at 4 GHz and 8 GHz [1355]:

$S_{11} = 0.54 \angle -120^\circ$, $S_{12} = 3.60 \angle 61^\circ$, $S_{12} = 0.137 \angle -31^\circ$, $S_{22} = 0.22 \angle -49^\circ$

$S_{11} = 0.60 \angle 87^\circ$, $S_{21} = 2.09 \angle -32^\circ$, $S_{12} = 0.21 \angle -36^\circ$, $S_{22} = 0.32 \angle -48^\circ$

Determine the stability parameters, stability circles, and stability regions at the two frequencies.

13.3 Derive the following relationships, where $R_G = \text{Re}(Z_G)$:

$$\frac{Z_G + Z_G}{2\sqrt{R_G Z_0}} = \frac{1}{\sqrt{1 - |\Gamma_G|^2}} \frac{|1 - \Gamma_G|}{|1 - \Gamma_G|} \Rightarrow Z_G = Z_0 \frac{|1 - \Gamma_G|^2}{|1 - \Gamma_G|^2}$$

13.4 Derive Eqs. (13.7.13) relating the generalized $S$-parameters of power waves to the conventional $S$-parameters.

13.5 Derive the expression Eq. (13.6.20) for the maximum available gain $G_{mag}$, and show that it is the maximum of all three gains, that is, transducer, available, and operating gains.

13.6 Computer Experiment. The microwave transistor of Example 13.11.2 has the following noise parameters at a frequency of 1 GHz [1355]: $F_{\text{min}} = 1.3 \text{ dB}$, $F_n = 0.16$, and $G_{opt} = 0.06 \angle 49^\circ$.

Determine the matched load $\Gamma_{opt}$ corresponding to $G_{opt}$ and calculate the available gain. Then, plot the noise figure circles for $F = 1.4, 1.5, 1.6 \text{ dB}$. For the 1.5-dB noise figure circle, determine the values of $\Gamma_G, \Gamma_L$ that correspond to the maximum possible available gain.

Design microstrip stub matching circuits for the computed values of $\Gamma_G, \Gamma_L$. 

Fig. 13.12.3 Maximum available gain for given noise figure.
13.7 Computer Experiment. The Hewlett-Packard ATF-36163 pseudomorphic high electron mobility transistor (PHEMT) has the following S- and noise parameters at 6 GHz [1355]:

\[
S_{11} = 0.75 \angle -131^\circ, \quad S_{21} = 3.95 \angle 55^\circ, \quad S_{12} = 0.13 \angle -12^\circ, \quad S_{22} = 0.27 \angle -116^\circ
\]

\[
F_{\text{min}} = 0.66 \text{ dB}, \quad r_n = 0.15, \quad \Gamma_{\text{Gopt}} = 0.55 \angle 88^\circ
\]

Plot the \( F = 0.7, 0.8, 0.9 \) dB noise figure circles. On the \( 0.7 \) dB circle, determine the source reflection coefficient \( \Gamma_C \) that corresponds to maximum available gain, and then determine the corresponding matched load coefficient \( \Gamma_L \).

Design microstrip stub matching circuits for the computed values of \( \Gamma_C, \Gamma_L \).

13.8 Computer Experiment. In this experiment, you will carry out two low-noise microwave amplifier designs, including the corresponding input and output matching networks. The first design fixes the noise figure and finds the maximum gain that can be achieved. The second design fixes the desired gain and finds the minimum noise figure that may be achieved.

The Hewlett-Packard Agilent ATF-34143 PHEMT transistor is suitable for low-noise amplifiers in cellular/PCS base stations, low-earth-orbit and multipoint microwave distribution systems, and other low-noise applications.

At 2 GHz, its S-parameters and noise-figure data are as follows, for biasing conditions of \( V_{DS} = 4 \) V and \( I_{DS} = 40 \) mA:

\[
S_{11} = 0.700 \angle -150^\circ, \quad S_{21} = 0.081 \angle 19^\circ, \quad S_{12} = 6.002 \angle 73^\circ, \quad S_{22} = 0.210 \angle -150^\circ
\]

\[
F_{\text{min}} = 0.22 \text{ dB}, \quad r_n = 0.09, \quad \Gamma_{\text{Gopt}} = 0.66 \angle 67^\circ
\]

a. At 2 GHz, the transistor is potentially unstable. Calculate the stability parameters \( K, \mu, \lambda, D_1, D_2 \). Calculate the MSG in dB.

Draw a basic Smith chart and place on it the source and load stability circles (display only a small portion of each circle outside the Smith chart.)

Then, determine the parts of the Smith chart that correspond to the source and load stability regions.

b. For the given optimum reflection coefficient \( \Gamma_{\text{Gopt}} \), calculate the corresponding load reflection coefficient \( \Gamma_{L\text{opt}} \) assuming a matched load.

Place the two points \( \Gamma_{\text{Gopt}}, \Gamma_{L\text{opt}} \) on the above Smith chart and determine whether they lie in their respective stability regions.

c. Calculate the available gain \( G_{\text{aopt}} \) in dB that corresponds to \( \Gamma_{\text{Gopt}} \).

Add the corresponding available gain circle to the above Smith chart. (Note that the source stability circle and the available gain circles intersect the Smith chart at the same points.)

d. Add to your Smith chart the noise figure circles corresponding to the noise figure values of \( F = 0.25, 0.30, 0.35 \) dB.

For the case \( F = 0.35 \) dB, calculate and plot the available gain \( G_a \) in dB as \( \Gamma_C \) traces the noise-figure circle. Determine the maximum value of \( G_a \) and the corresponding value of \( \Gamma_C \).

Place on your Smith chart the available gain circle corresponding to this maximum \( G_a \). Place also the corresponding point \( \Gamma_C \), which should be the point of tangency between the gain and noise figure circles.

calculate and place on the Smith chart the corresponding load reflection coefficient \( \Gamma_L = \Gamma_{\text{Lopt}} \). Verify that the two points \( \Gamma_C, \Gamma_L \) lie in their respective stability regions.

In addition, for comparison purposes, place on your Smith chart the available gain circles corresponding to the values \( G_a = 15 \) and \( 16 \) dB.

e. The points \( \Gamma_C \) and \( \Gamma_L \) determined in the previous question achieve the maximum gain for the given noise figure of \( F = 0.35 \) dB.

Design input and output stub matching networks that match the amplifier to a 50-ohm generator and a 50-ohm load. Use "parallel/open" microstrip stubs having 50-ohm characteristic impedance and alumina substrate of relative permittivity of \( \epsilon_r = 9.8 \).

Determine the stub lengths \( d, l \) in units of \( \lambda \), the wavelength inside the microstrip lines. Choose always the solution with the shortest total length \( d + l \).

Determine the effective permittivity \( \epsilon_{\text{eff}} \) of the stubs, the stub wavelength \( \lambda \) in cm, and the width/height ratio, \( w/h \). Then, determine the stub lengths \( d, l \) in cm.

Finally, make a schematic of your final design that shows both the input and output matching networks (as in Fig.10.8.3.)

f. The above design sets \( F = 0.35 \) dB and finds the maximum achievable gain. Carry out an alternative design as follows. Start with a desired available gain of \( G_a = 16 \) dB and draw the corresponding available gain circle on your Smith chart.

As \( \Gamma_C \) traces the portion of this circle that lies inside the Smith chart, compute the corresponding noise figure \( F \). (Points on the circle can be parametrized by \( \Gamma_C = c + r e^{ij} \), but you must keep only those that have \( |\Gamma_C| < 1 \).)

Find the minimum among these values of \( F \) in dB and calculate the corresponding value of \( \Gamma_C \). Calculate the corresponding matched \( \Gamma_L \).

Add to your Smith chart the corresponding noise figure circle and place on it the points \( \Gamma_C \) and \( \Gamma_L \).

g. Design the appropriate stub matching networks as in part 13.8. Calculate and place on the Smith chart the corresponding load reflection coefficient \( \Gamma_L = \Gamma_{\text{Lopt}} \). Verify that the two points \( \Gamma_C, \Gamma_L \) lie in their respective stability regions.
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**Introduction**

Network analysis is the process by which designers and manufacturers measure the electrical performance of the components and circuits used in more complex systems. When these systems are conveying signals with information content, we are most concerned with getting the signal from one point to another with maximum efficiency and minimum distortion. Vector network analysis is a method of accurately characterizing such components by measuring their effect on the amplitude and phase of swept-frequency and swept-power test signals.

In this application note, the fundamental principles of vector network analysis will be reviewed. The discussion includes the common parameters that can be measured, including the concept of scattering parameters (S-parameters). RF fundamentals such as transmission lines and the Smith chart will also be reviewed.

Agilent Technologies offers a wide range of portable and benchtop vector network analyzers for characterizing components from DC to 110 GHz. These instruments are available with a wide range of options to simplify testing in the field, laboratory, and production environments.

**Measurements in Communications Systems**

In any communications system, the effect of signal distortion must be considered. While we generally think of the distortion caused by nonlinear effects (for example, when intermodulation products are produced from desired carrier signals), purely linear systems can also introduce signal distortion. Linear systems can change the time waveform of signals passing through them by altering the amplitude or phase relationships of the spectral components that make up the signal.

Let’s examine the difference between linear and nonlinear behavior more closely.

Linear devices impose magnitude and phase changes on input signals (Figure 1). Any sinusoid appearing at the input will also appear at the output, and at the same frequency. No new signals are created. Both active and passive nonlinear devices can shift an input signal in frequency or add other frequency components, such as harmonic and spurious signals. Large input signals can drive normally linear devices into compression or saturation, causing nonlinear operation.

![Linear versus nonlinear behavior](image)

*Figure 1. Linear versus nonlinear behavior*
For linear distortion-free transmission, the amplitude response of the device under test (DUT) must be flat and the phase response must be linear over the desired bandwidth. As an example, consider a square-wave signal rich in high-frequency components passing through a bandpass filter that passes selected frequencies with little attenuation while attenuating frequencies outside of the passband by varying amounts.

Even if the filter has linear phase performance, the out-of-band components of the square wave will be attenuated, leaving an output signal that, in this example, is more sinusoidal in nature (Figure 2).

If the same square-wave input signal is passed through a filter that only inverts the phase of the third harmonic, but leaves the harmonic amplitudes the same, the output will be more impulse-like in nature (Figure 3). While this is true for the example filter, in general, the output waveform will appear with arbitrary distortion, depending on the amplitude and phase nonlinearities.

F(t) = \sin wt + \frac{1}{3} \sin 3wt + \frac{1}{5} \sin 5wt

Figure 2. Magnitude variation with frequency

F(t) = \sin wt + \frac{1}{3} \sin 3wt + \frac{1}{5} \sin 5wt

Figure 3. Phase variation with frequency
Nonlinear devices also introduce distortion (Figure 4). For example, if an amplifier is overdriven, the output signal clips because the amplifier is saturated. The output signal is no longer a pure sinusoid, and harmonics are present at multiples of the input frequency. Passive devices may also exhibit nonlinear behavior at high power levels, a good example of which is an L-C filter that uses inductors with magnetic cores. Magnetic materials often exhibit hysteresis effects that are highly nonlinear.

Efficient transfer of power is another fundamental concern in communications systems. In order to efficiently convey, transmit or receive RF power, devices such as transmission lines, antennas and amplifiers must present the proper impedance match to the signal source. Impedance mismatches occur when the real and imaginary parts of input and output impedances are not ideal between two connecting devices.

Importance of Vector Measurements

Measuring both magnitude and phase of components is important for several reasons. First, both measurements are required to fully characterize a linear network and ensure distortion-free transmission. To design efficient matching networks, complex impedance must be measured. Engineers developing models for computer-aided-engineering (CAE) circuit simulation programs require magnitude and phase data for accurate models.

In addition, time-domain characterization requires magnitude and phase information in order to perform an inverse-fourier transform. Vector error correction, which improves measurement accuracy by removing the effects of inherent measurement-system errors, requires both magnitude and phase data to build an effective error model. Phase-measurement capability is very important even for scalar measurements such as return loss, in order to achieve a high level of accuracy (see Applying Error Correction to Network Analyzer Measurements, Agilent application note 1287-3).
The Basis of Incident and Reflected Power

In its fundamental form, network analysis involves the measurement of incident, reflected, and transmitted waves that travel along transmission lines. Using optical wavelengths as an analogy, when light strikes a clear lens (the incident energy), some of the light is reflected from the lens surface, but most of it continues through the lens (the transmitted energy) (Figure 5). If the lens has mirrored surfaces, most of the light will be reflected and little or none will pass through it.

While the wavelengths are different for RF and microwave signals, the principle is the same. Network analyzers accurately measure the incident, reflected, and transmitted energy, e.g., the energy that is launched onto a transmission line, reflected back down the transmission line toward the source (due to impedance mismatch), and successfully transmitted to the terminating device (such as an antenna).

![Lightwave analogy](image)

*Figure 5. Lightwave analogy to high-frequency device characterization*

The Smith Chart

The amount of reflection that occurs when characterizing a device depends on the impedance that the incident signal “sees.” Since any impedance can be represented with real and imaginary parts ($R + jX$ or $G + jB$), they can be plotted on a rectilinear grid known as the complex impedance plane. Unfortunately, an open circuit (a common RF impedance) appears at infinity on the real axis, and therefore cannot be shown.

The polar plot is useful because the entire impedance plane is covered. However, instead of plotting impedance directly, the complex reflection coefficient is displayed in vector form. The magnitude of the vector is the distance from the center of the display, and phase is displayed as the angle of vector referenced to a flat line from the center to the right-most edge. The drawback of polar plots is that impedance values cannot be read directly from the display.
Since there is a one-to-one correspondence between complex impedance and reflection coefficient, the positive real half of the complex impedance plane can be mapped onto the polar display. The result is the Smith chart. All values of reactance and all positive values of resistance from 0 to infinity fall within the outer circle of the Smith chart (Figure 6).

On the Smith chart, loci of constant resistance appear as circles, while loci of constant reactance appear as arcs. Impedances on the Smith chart are always normalized to the characteristic impedance of the component or system of interest, usually 50 ohms for RF and microwave systems and 75 ohms for broadcast and cable-television systems. A perfect termination appears in the center of the Smith chart.

![Smith chart](image)

**Figure 6. Smith chart review**

**Power Transfer Conditions**

A perfectly matched condition must exist at a connection between two devices for maximum power transfer into a load, given a source resistance of $R_s$ and a load resistance of $R_L$. This condition occurs when $R_L = R_s$, and is true whether the stimulus is a DC voltage source or a source of RF sine waves (Figure 7).

When the source impedance is not purely resistive, maximum power transfer occurs when the load impedance is equal to the complex conjugate of the source impedance. This condition is met by reversing the sign of the imaginary part of the impedance. For example, if $R_s = 0.6 + j 0.3$, then the complex conjugate is $R_s^* = 0.6 - j 0.3$.

The need for efficient power transfer is one of the main reasons for the use of transmission lines at higher frequencies. At very low frequencies (with much larger wavelengths), a simple wire is adequate for conducting power. The resistance of the wire is relatively low and has little effect on low-frequency signals. The voltage and current are the same no matter where a measurement is made on the wire.
At higher frequencies, wavelengths are comparable to or smaller than the length of the conductors in a high-frequency circuit, and power transmission can be thought of in terms of traveling waves. When the transmission line is terminated in its characteristic impedance, maximum power is transferred to the load. When the termination is not equal to the characteristic impedance, that part of the signal that is not absorbed by the load is reflected back to the source.

If a transmission line is terminated in its characteristic impedance, no reflected signal occurs since all of the transmitted power is absorbed by the load (Figure 8). Looking at the envelope of the RF signal versus distance along the transmission line shows no standing waves because without reflections, energy flows in only one direction.

![Figure 7. Power transfer](image)

For complex impedances, maximum power transfer occurs when \( Z_L = Z_S^* \) (conjugate match).

\[
Z_s = R + jX \\
Z_L = Z_s^* = R - jX
\]

![Figure 8. Transmission line terminated with \( Z_0 \)](image)

For reflection, a transmission line terminated in \( Z_0 \) behaves like an infinitely long transmission line.

\[
V_{\text{inc}} \quad V_{\text{refl}} = 0 \quad \text{(all the incident power is absorbed in the load)}
\]
When the transmission line is terminated in a short circuit (which can sustain no voltage and therefore dissipates zero power), a reflected wave is launched back along the line toward the source (Figure 9). The reflected voltage wave must be equal in magnitude to the incident voltage wave and be 180 degrees out of phase with it at the plane of the load. The reflected and incident waves are equal in magnitude but traveling in the opposite directions.

If the transmission line is terminated in an open-circuit condition (which can sustain no current), the reflected current wave will be 180 degrees out of phase with the incident current wave, while the reflected voltage wave will be in phase with the incident voltage wave at the plane of the load. This guarantees that the current at the open will be zero. The reflected and incident current waves are equal in magnitude, but traveling in the opposite directions. For both the short and open cases, a standing wave pattern is set up on the transmission line. The voltage valleys will be zero and the voltage peaks will be twice the incident voltage level.

If the transmission line is terminated with say a 25-ohm resistor, resulting in a condition between full absorption and full reflection, part of the incident power is absorbed and part is reflected. The amplitude of the reflected voltage wave will be one-third that of the incident wave, and the two waves will be 180 degrees out of phase at the plane of the load. The valleys of the standing-wave pattern will no longer be zero, and the peaks will be less than those of the short and open cases. The ratio of the peaks to valleys will be 2:1.

The traditional way of determining RF impedance was to measure VSWR using an RF probe/detector, a length of slotted transmission line, and a VSWR meter. As the probe was moved along the transmission line, the relative position and values of the peaks and valleys were noted on the meter. From these measurements, impedance could be derived. The procedure was repeated at different frequencies. Modern network analyzers measure the incident and reflected waves directly during a frequency sweep, and impedance results can be displayed in any number of formats (including VSWR).

For reflection, a transmission line terminated in a short or open reflects all power back to source

Figure 9. Transmission line terminated with short, open
Network Analysis Terminology

Now that we understand the fundamentals of electromagnetic waves, we must learn the common terms used for measuring them. Network analyzer terminology generally denotes measurements of the incident wave with the R or reference channel. The reflected wave is measured with the A channel, and the transmitted wave is measured with the B channel (Figure 10). With the amplitude and phase information in these waves, it is possible to quantify the reflection and transmission characteristics of a DUT. The reflection and transmission characteristics can be expressed as vector (magnitude and phase), scalar (magnitude only), or phase-only quantities. For example, return loss is a scalar measurement of reflection, while impedance is a vector reflection measurement. Ratioed measurements allow us to make reflection and transmission measurements that are independent of both absolute power and variations in source power versus frequency. Ratioed reflection is often shown as A/R and ratioed transmission as B/R, relating to the measurement channels in the instrument.

![Figure 10: Common terms for high-frequency device characterization](image)

The most general term for ratioed reflection is the complex reflection coefficient, $\Gamma$ or gamma (Figure 11). The magnitude portion of $\Gamma$ is called $\rho$ or rho. The reflection coefficient is the ratio of the reflected signal voltage level to the incident signal voltage level. For example, a transmission line terminated in its characteristic impedance $Z_o$ will have all energy transferred to the load so $V_{\text{refl}} = 0$ and $\rho = 0$. When the impedance of the load, $Z_L$ is not equal to the characteristic impedance, energy is reflected and $\rho$ is greater than zero. When the load impedance is equal to a short or open circuit, all energy is reflected and $\rho = 1$. As a result, the range of possible values for $\rho$ is 0 to 1.
Reflection coefficient

\[ \Gamma = \frac{V_{\text{reflected}}}{V_{\text{incident}}} = r \begin{vmatrix} F \end{vmatrix} = \frac{Z_L - Z_0}{Z_L + Z_0} \]

Return loss = \(-20 \log(\rho), \rho = |\Gamma|\)

Voltage standing wave ratio

\[ \text{VSWR} = \frac{E_{\text{max}}}{E_{\text{min}}} = \frac{1 + r}{1 - r} \]

No reflection

\(Z_L = Z_0\)

\(0 \quad \infty \quad 0 \quad 0 \quad \)

\(\rho \quad \text{RL} \quad \text{dB} \quad \text{VSWR} \quad \infty \quad 1 \quad 1 \quad \)

Full reflection

\(Z_L = \text{open, short}\)

Return loss is a way to express the reflection coefficient in logarithmic terms (decibels). Return loss is the number of decibels that the reflected signal is below the incident signal. Return loss is always expressed as a positive number and varies between infinity for a load at the characteristic impedance and 0 dB for an open or short circuit. Another common term used to express reflection is voltage standing wave ratio (VSWR), which is defined as the maximum value of the RF envelope over the minimum value of the RF envelope. It is related to \(\rho\) as \((1 + \rho)/(1 - \rho)\). VSWR ranges from 1 (no reflection) to infinity (full reflection).

The transmission coefficient is defined as the transmitted voltage divided by the incident voltage (Figure 12). If the absolute value of the transmitted voltage is greater than the absolute value of the incident voltage, a DUT or system is said to have gain. If the absolute value of the transmitted voltage is less than the absolute value of the incident voltage, the DUT or system is said to have attenuation or insertion loss. The phase portion of the transmission coefficient is called insertion phase.

**Figure 11. Reflection parameters**

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Direct examination of insertion phase usually does not provide useful information. This is because the insertion phase has a large (negative) slope with respect to frequency due to the electrical length of the DUT. The slope is proportional to the length of the DUT. Since it is only deviation from linear phase that causes distortion in communications systems, it is desirable to remove the linear portion of the phase response to analyze the remaining nonlinear portion. This can be done by using the electrical delay feature of a network analyzer to mathematically cancel the average electrical length of the DUT. The result is a high-resolution display of phase distortion or deviation from linear phase (Figure 13).

![Use electrical delay to remove linear portion of phase response](image)

**Figure 13. Deviation from linear phase**

**Measuring Group Delay**

Another useful measure of phase distortion is group delay (Figure 14). This parameter is a measure of the transit time of a signal through a DUT versus frequency. Group delay can be calculated by differentiating the DUT’s phase response versus frequency. It reduces the linear portion of the phase response to a constant value, and transforms the deviations from linear phase into deviations from constant group delay, (which causes phase distortion in communications systems). The average delay represents the average signal transit time through a DUT.

![Group delay diagram](image)

**Figure 14. What is group delay?**
Depending on the device, both deviation from linear phase and group delay may be measured, since both can be important. Specifying a maximum peak-to-peak phase ripple in a device may not be sufficient to completely characterize it, since the slope of the phase ripple depends on the number of ripples that occur per unit of frequency. Group delay takes this into account because it is the differentiated phase response. Group delay is often a more easily interpreted indication of phase distortion (Figure 15).

![Figure 15. Why measure group delay?](image)

**Network Characterization**

In order to completely characterize an unknown linear two-port device, we must make measurements under various conditions and compute a set of parameters. These parameters can be used to completely describe the electrical behavior of our device (or network), even under source and load conditions other than when we made our measurements. Low-frequency device or network characterization is usually based on measurement of H, Y, and Z parameters. To do this, the total voltage and current at the input or output ports of a device or nodes of a network must be measured. Furthermore, measurements must be made with open-circuit and short-circuit conditions.

Since it is difficult to measure total current or voltage at higher frequencies, S-parameters are generally measured instead (Figure 16). These parameters relate to familiar measurements such as gain, loss, and reflection coefficient. They are relatively simple to measure, and do not require connection of undesirable loads to the DUT. The measured S-parameters of multiple devices can be cascaded to predict overall system performance. S-parameters are readily used in both linear and nonlinear CAE circuit simulation tools, and H, Y, and Z parameters can be derived from S-parameters when necessary.

The number of S-parameters for a given device is equal to the square of the number of ports. For example, a two-port device has four S-parameters. The numbering convention for S-parameters is that the first number following the S is the port at which energy emerges, and the second number is the port at which energy enters. So $S_{21}$ is a measure of power emerging from Port 2 as a result of applying an RF stimulus to Port 1. When the numbers are the same (e.g. $S_{11}$), a reflection measurement is indicated.
Forward S-parameters are determined by measuring the magnitude and phase of the incident, reflected, and transmitted signals when the output is terminated in a load that is precisely equal to the characteristic impedance of the test system. In the case of a simple two-port network, $S_{11}$ is equivalent to the input complex reflection coefficient or impedance of the DUT, while $S_{21}$ is the forward complex transmission coefficient. By placing the source at the output port of the DUT and terminating the input port in a perfect load, it is possible to measure the other two (reverse) S-parameters. Parameter $S_{22}$ is equivalent to the output complex reflection coefficient or output impedance of the DUT while $S_{12}$ is the reverse complex transmission coefficient (Figure 17).
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An Introduction to RF Measurements With a Vector Network Analyzer

Instrument manufacturers’ application notes provide essential lessons on measurement procedures

This month’s review of RF fundamentals is about the vector network analyzer (VNA). Descriptions of VNA operation, calibration, measurement methods and data presentation are adapted from several excellent application notes available from VNA manufacturers. They are the primary source of reliable information on these valuable RF/microwave test instruments.

VNA Operation

The vector network analyzer includes a swept signal source and a tuned receiver that is synchronized to the frequency of the test signal. The receiver also monitors the test signal source, establishing a fixed point of reference for phase and amplitude, the two basic measurements it performs.

The amplitude and phase information received from the device under test (DUT) is compared to the reference to determine the relative difference. Various parameters can be computed from the measurements as illustrated in Figure 1. Some of these measurements are amplitude-only (scalar), some are phase-only (time delay), but most are a combination that take advantage of the VNA’s ability to do both.

The signal source is continuous (CW), with the only variations being the choice of amplitude and the frequency sweep range for a particular measurement. In the receiver, the signal from the DUT is converted into the passband of the IF, where it is amplified and detected for measurement.

To measure the phase of this signal after it passes through, or is reflected by the DUT, we must have a point of reference. The phase reference is obtained by splitting off a portion of the source signal before the measurement. The phase of the microwave signal after it has passed through the DUT is then compared with the reference signal. A network analyzer test set automatically samples the reference signal, so no external hardware is needed.

MEASUREMENTS

- Gain (dB)
- Insertion Loss (dB)
- Insertion Phase (degrees)
- Transmission Coefficients (S12, S21)
- Separations of Transmission Components (Real and Imaginary)
- Electrical Length (m)
- Electrical Delay (s)
- Deviation from Linear Phase (degrees)
- Group Delay (s)

FIGURE 1
Transmission (top) and Reflection (bottom) measurements performed by a VNA. (After [1])
If the phase of a signal is 90 degrees different from the reference signal, the vector network analyzer would read this as –90 degrees, since the test signal is delayed with respect to the reference signal. At a specific frequency, this 90 degree phase shift will correspond to a time delay equal to the propagation of a signal at the speed of light, over a distance of 1/4 wavelength (360 degrees = 1 wavelength). This is a function of frequency, so such time measurements must be calculated after the phase is measured.

Similarly, amplitude is compared to the test signal to determine gain or loss in the DUT.

Figure 2 shows a simplified diagram of the signal paths during VNA measurements. A signal source provides the stimulus to the DUT port under test, with the opposite port terminated in the VNA. Directional couplers in each path sample the forward and reflected signals, which are amplified and detected in the receiver, followed by computation of the desired measurement parameters.

The blocks marked “Interface” include interconnecting cables and connectors external to the VNA unit. To measure an individual component, the “Interface” will also include the additional connectors and circuit board traces up to the terminals of the device itself. For consistent measurement results, test fixtures are available or common components, or may be custom fabricated as needed.

For an amplifier, filter, or other transmission measurement, the excitation signal is applied to the DUT input, with the output terminated. The input and output amplitude and phase are compared in the VNA to obtain results for gain/loss, and...
phase shift/delay ($S_{12}$). The reflected port on the input coupler provides a sample for determining input impedance ($S_{11}$) or VSWR. When the source and termination are reversed, the VNA can make measurements of output impedance ($S_{22}$) and reverse path characteristics ($S_{21}$).

One-port measurements may be needed for devices with other means of termination, or for antenna measurements. In this case, the test signal is applied in the forward direction and the VNA simply does not use the output coupler data.

Multiport measurements may also be desired, for devices like power divider/combiners, couplers, and balanced circuits. Although important, a description of the process is beyond the scope of a “first tutorial” like this one. Interested readers are directed to the many available references available in technical papers and application notes.

The Importance of Calibration

Both phase and amplitude measurements must be calibrated to eliminate the effects of different lengths and variations in gain or loss of the signal paths within the instrument. Further, the effects of test cables and, as noted above, perhaps the mounting fixture, must also be included in the calibration process to assure that the performance of the DUT is the sole result of the test.

Remember, RF/microwave measurements are made over a range of frequencies. Frequency-dependent effects are always present—phase shift due to changing wavelength, increasing loss with frequency, as well as the frequency response of devices and circuits. These effects must be part of the calibration process, so it is easy to see that the ideal VNA calibration, covering its entire operating frequency range, would require a large amount of data to be measured, stored and applied to the desired measurements.

The most common method of calibration is the through-reflection-line (TRL) technique [3]. The TRL calibration technique relies only on the characteristic impedance of a short transmission line. From two sets of 2-port measurements that differ by this short length of transmission line and two reflection measurements, the full 12-term error model can be determined. Due to the simplicity of the calibration standards, TRL can be applied in dispersive transmission media such as microstrip, stripline and waveguide. Using precision coaxial transmission lines for calibration, TRL currently provides the highest accuracy in coaxial measurements available today.

Many different names have been given to this overall approach: Self Calibration, Thru-Short-Delay, Thru-Reflect-Line, Thru-Reflect-Match, Line-Reflect-
Line, Line-Reflect-Match, and others. These techniques are all variations on the same basic approach.

TRL is an approach to 2-port calibration that relies on transmission lines rather than a set of discrete impedance standards. The technique results in the a 12-term error correction model that assures accurate measurements after calibration.

There are three key advantages gained when using transmission lines as reference standards [3]:

1. Transmission lines are among the simplest elements to realize, especially in non-coaxial media such as microstrip or stripline.
2. The impedance of transmission lines can be accurately determined from physical dimensions and materials characteristics.
3. Transmission lines have traditionally been used as standards and are well understood.

“TRL” refers to the three basic steps in the calibration process:

Through—connection of port 1 and port 2, directly or with a short length of transmission line
Reflection—connect identical one-port high reflection coefficient devices to each port. Typically, these will be short-circuit terminations.
Line—insert a short length of transmission line between ports 1 and 2. Through and Line must have different line lengths.

VNA manufacturers and other vendors offer precision calibration kits for TRL and other methods of calibration.

Viewing the Results
After obtaining the various measurement results, the VNA user can choose the format for display of the results—parameter, frequency range, and display type. Basic parameters measured include:

- S parameters ($S_{11}, S_{12}, S_{21}, S_{22}$)
- Voltage Standing Wave Ratio (VSWR)
- Reflection Coefficient ($\Gamma, \rho$)
- Return Loss
- Impedance ($R \pm jX$)
- Admittance ($G \pm jB$)
- Gain or Loss (Linear or dB)
- Isolation
- Insertion Phase
- Group Delay

More complex nonlinear measurements are available if the VNA has adjustable power levels, dual receivers, and other features:

- Harmonic Levels
- Mixer/Multiplier measurements
- Compression Point ($P_{1dB}$)
- DUT Output Power (dBm)
- Power-Added Efficiency (PAE)
- Stability Factor ($K$-factor)
- AM-PM Conversion
- Custom setup with user-defined equations

A set of VNA measurements that includes nonlinear parameters is shown in Figure 3.

The above measurements may be displayed in various formats: linear scale, log scale, vector (Mag/Angle) or Smith chart (Figure 4). The choice of display is selectable by the user, who can choose which parameters to include, along with the appropriate frequency range (horizontal) and scaling (vertical).

All current VNA products allow both internal and
external control by a PC, including measurement setup and storage of the results for archiving or post-processing.

A Final Note on New Low-Cost VNAs

Over the past 10 years, a number of analyzers have become available that perform many of the same measurements as the traditional VNAs that are the basis of this tutorial. These units take advantage of recent developments in signal source technology and the power of modern personal computers, enabling vector measurements at very low cost.

These inexpensive units do not have the noise figure, dynamic range, accuracy, stability or features of high-end instruments, and rarely operate above 1 GHz. However, they are proving valuable as alternatives, particularly where their very low cost allows less-critical or preliminary vector measurements to be made at any engineer's (or even a serious hobbyist's) workbench.

References

4. “Performing Amplifier Measurements with the Vector Network Analyzer ZVB,” Application Note 1EZ54, Rohde & Schwarz: www.rohde-schwarz.com